Technical Documents

Tools \& Software

# DLPC350 DLP® Digital Controller for DLP4500 and DLP4500NIR DMDs 

## 1 Features

- Required for Reliable Operation of the DLP4500 and DLP4500NIR DMDs
- High Speed Pattern Display Mode
- 1-Bit Binary Pattern Rates to 4225 Hz
- 8-Bit Grayscale Pattern Rates to 120 Hz
- 1-to-1 Input Mapping to Micromirrors
- Multiple Bit Depths and LEDs in Pattern Sequences
- Easy Synchronization With Cameras and Sensors
- Two Configurable Input Triggers
- Two Configurable Output Triggers
- 14 Fully Programmable GPIO Signals
- 64 Mb Internal RAM
- Stores up to 48 1-Bit Patterns
- No External Volatile Memory Required
- Supports up to 32 MB External Parallel Flash for Increased Pattern Storage
- Multiple Configuration Interfaces
- One USB 1.1 SlavePort
- Two I ${ }^{2}$ C Ports
- LED PWM Generators
- Video Display Mode of Operation
- 10- to $120-\mathrm{Hz}$ Full Color Frame Rates
- YUV, YCrCb, or RGB Input Data Formats
- Integrated Micromirror Drivers
- Integrated Clock Generation


## 2 Applications

- Machine Vision
- 3D Depth Measurement and Capture
- Robotic Guidance
- Inline Surface Inspection
- Pick and Place
- Spectrometers (Chemical Analysis)
- Process Analyzers
- Laboratory Equipment
- Dedicated Analyzers
- 3D Printers
- Medical Instruments
- 3D Dental Scanners
- 3D Biometrics
- Fingerprint Recognition
- Facial Recognition
- Single-Pixel Cameras
- Laser Marking


## 3 Description

The DLPC350 digital controller is required for reliable operation of the DLP4500 or DLP4500NIR digital micromirror device (DMD). The DLPC350 controller provides a convenient, multi-functional interface between user electronics and the DMD, enabling high-speed pattern rates, along with LED control and data formatting for multiple input formats.
The DLPC350 controller provides input and output trigger signals for synchronizing displayed patterns with a camera, sensor, or other peripherals. The controller enables integration into small-form-factor and low-cost light steering applications. Applications include 3D scanning or metrology systems, spectrometers, interactive displays, chemical analyzers, medical instruments, and other end equipment that requires spatial light modulation (light steering and patterning).
The DLPC350 controller is the data formatting and DMD controlling ASIC for either the visible or nearinfrared (NIR) version of the DLP4500. For further details, please see the DLPR350 firmware homepage and the DLP4500 data sheet.

Device Information ${ }^{(1)}$

| ORDER NUMBER | PACKAGE | BODY SIZE |
| :--- | :--- | :---: |
| DLPC350 | BGA (419) | $23.4 \times 23.4 \mathrm{~mm}$ |

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Simplified System Block Diagram


- Vascular Imaging
- Microscopes


## Table of Contents

1 Features ..... 1
2 Applications ..... 1
3 Description ..... 1
4 Revision History. ..... 2
5 Pin Configuration and Functions ..... 4
6 Specifications ..... 12
6.1 Absolute Maximum Ratings ..... 12
6.2 ESD Ratings ..... 12
6.3 Recommended Operating Conditions ..... 13
6.4 Thermal Information ..... 13
6.5 I/O Electrical Characteristics ..... 14
$6.6 \mathrm{I}^{2} \mathrm{C} 0$ and $\mathrm{I}^{2} \mathrm{C} 1$ Interface Timing Requirements ..... 15
6.7 Port 1 Input Pixel Interface Timing Requirements ..... 16
6.8 Port 2 Input Pixel Interface (FPD-Link Compatible LVDS Input) Timing Requirements ..... 16
6.9 System Oscillator Timing Requirements ..... 16
6.10 Reset Timing Requirements ..... 17
6.11 Video Timing Input Blanking Specification ..... 20
6.12 Programmable Output Clocks Switching Characteristics ..... 22
6.13 DMD Interface Switching Characteristics ..... 23
6.14 JTAG Interface: I/O Boundary Scan Application
Switching Characteristics ..... 25
7 Parameter Measurement Information ..... 26
7.1 Power Consumption ..... 26
8 Detailed Description ..... 27
8.1 Overview ..... 27
8.2 Functional Block Diagram ..... 28
8.3 Feature Description ..... 30
8.4 Device Functional Modes ..... 31
9 Application and Implementation ..... 35
9.1 Application Information. ..... 35
9.2 Typical Applications ..... 35
10 Power Supply Recommendations ..... 40
10.1 System Power and Reset ..... 40
11 Layout. ..... 45
11.1 Layout Guidelines ..... 45
11.2 Layout Example ..... 50
12 Device and Documentation Support ..... 55
12.1 Device Support. ..... 55
12.2 Documentation Support ..... 56
12.3 Trademarks ..... 56
12.4 Electrostatic Discharge Caution. ..... 56
12.5 Glossary ..... 56
13 Mechanical, Packaging, and Orderable Information ..... 56

## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.
Changes from Revision C (March 2014) to Revision D ..... Page

- Changed title of datasheet to DLPC350 DLP Digital Controller for DLP4500 and DLP4500NIR DMDs ..... 1
- Updated "High Speed Pattern Sequence Mode" to "High Speed Pattern Display Mode" in Features ..... 1
- Corrected internal RAM space to 64 Mb and deleted redundant "Stores up to 48 1-Bit Patterns". ..... 1
- Moved External Parallel Flash up to bullet point; changed 64 MB to 32 MB ..... 1
- Changed "Video Projection Mode" to "Video Display Mode" ..... 1
- Deleted "Extensive Video Processing Capability" ..... 1
- Changed several phrases in description ..... 1
- Changed "NIR" to "near-infrared (NIR)" ..... 1
- Added direct links to DLPR350 firmware and DLP4500 data sheet. ..... 1
- Changed Description field of I2C_ADDR_SEL in Pin Function Descriptions ..... 5
- Changed I2C bus max to reference $I^{2} C 0$ and $R^{2} C 1$ Interface Timing Requirements ${ }^{(1)(2)(3)}$ in Pin Function Descriptions table ..... 5
- Moved and changed "e.g. HDMI, BT656" in Pin Function Descriptions table ..... 5
- Updated note on ICTSEN and TRST in description column of Pin Function Descriptions table ..... 10
- Removed Machine Model ESD information from ESD Ratings. ..... 12
- Changed Operating junction temperature to $105^{\circ} \mathrm{C}$ in Recommended Operating Conditions ..... 13
- Changed table notes for $P^{2} C 0$ and $F^{2} C 1$ Interface Timing Requirements ${ }^{(1)(2)(3)}$ ..... 15
- Added exception for 120 Hz source in Source Input Blanking. ..... 20
- Added VSYNC and HSYNC high value to Table 3 ..... 20
- Added Table 4 ..... 20
- Added Figure 7 ..... 21
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Revision History (continued)
- Added clarification on putting DLPC350 in tri-state during JTAG boundary scan in Board Level Test Support ..... 30
- Changed "48 bit-plane" to "48 1-bit planes" in Structured Light Applications ..... 31
- Clarified wording about mapping options in (LVDS) Receiver Supported Pixel Mapping Modes ..... 34
- Added Link to DLPR350 firmware page ..... 36
- Corrected flash access read and write timing to fixed values ..... 38
- Removed subsection Application Performance Plot and figure ..... 40
- Changed Figure 23 to reference DLPC350 and INIT_BUSY timing to 2.3 s max ..... 44
- Added DLPC350 Configuration and Support Firmware (DLPR350) in Related Documentation. ..... 56
Changes from Revision B (September 2013) to Revision C ..... Page
- Updated to new TI standards and rearranged content for the new data sheet flow ..... 1
- Clarified the description for POWER_ON_OFF pin in the Pin Function Descriptions ..... 4
- Moved the pin descriptions as part of new data sheet flow ..... 4
- Removed empty Conditions column from Absolute Maximum Ratings. ..... 12
- Separated the handling ratings from the absolute maximum ratings ..... 12
- Removed empty Conditions column from the Recommended Operating Conditions table ..... 13
- Added Device and Documentation Support section ..... 55
Changes from Revision A (May 2013) to Revision B Page
- Added PIB_CLK and P1C_CLK to Pin Function Descriptions ..... 5
- Deleted $\overline{\text { PM_CS_0 }}$ from FLASH INTERFACE in Pin Function Descriptions. ..... 8
- Deleted Y16 and AB17 from the RESERVED PINS list in Pin Function Descriptions ..... 10
- Added $\overline{\text { PM_CS_0 }}$ to the RESERVED PINS LIST in Pin Function Descriptions ..... 10
- Deleted "PM_CS_0 - available for optional Flash device ( $\leq 128 \mathrm{Mb}$ )" From the Program Memory Flash Interface section ..... 38
Changes from Original (April 2013) to Revision A Page
- Changed the device From: Preview To: Production. ..... 1


## 5 Pin Configuration and Functions


(1) See General Handling Guidelines for Unused CMOS-Type Pins in the Layout section for instructions on handling unused pins.
(2) I/O Type: I indicates input, O indicates output, B indicates bidirectional, and H indicates hysteresis. See Table 2 for subscript explanation.

Pin Functions (continued)

| PIN ${ }^{(1)}$ |  | $\begin{gathered} \text { I/O } \\ \text { POWER } \end{gathered}$ | $\begin{aligned} & \text { I/O } \\ & \text { TYPE } \end{aligned}$${ }_{(2)}$ | INTERNAL TERMINATION | CLK <br> SYSTEM | DESCRIPTION |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| NAME | NUMBER |  |  |  |  |  |
| EXT_PWR_ON | D21 | VDD33 | $\mathrm{B}_{2}$ |  | Async | Signal to host processor or power supply to indicate that the DLPC350 controller is powered on. Asserted just before INIT_DONE. |
| HOLD_IN_BOOT | D18 | VDD33 | $\mathrm{B}_{2}$ | External pullup required | N/A |  |
| INIT_DONE | F19 | VDD33 | $\mathrm{B}_{2}$ |  | Async | Prior to transferring part of code from parallel flash content to internal memory, the internal memory is initialized and a memory test is performed. The result of this test (pass or fail) is recorded in the system status. If the memory test fails, the initialization process is halted. INIT_DONE is asserted twice to indicate an error situation. See Figure 23 and note that GPIO26 is the INIT_DONE signal. |
| I2C_ADDR_SEL | F21 | VDD33 | $\mathrm{B}_{2}$ |  | Async | This signal is sampled during power-up. If the signal is low, the $I^{2} \mathrm{C}$ slave addresses are $0 \times 34$ and $0 \times 35$. If the signal is high, the $I^{2} \mathrm{C}$ slave addresses are $0 \times 3 \mathrm{~A}$ and $0 \times 3 \mathrm{~B}$. After the system has been initialized, this signal is available as a GPIO. |
| I2C1_SCL | J3 | VDD33 | $\mathrm{B}_{2}$ | Requires an external pullup to 3.3 V . The minimum acceptable pullup value is 1 $k \Omega$. | N/A | $1^{2} \mathrm{C}$ clock. bidirectional, open-drain signal. $\mathrm{I}^{2} \mathrm{C}$ slave clock input from the external processor. This bus supports the frequency as specified in $R^{2} C O$ and ${ }^{2} C 1$ Interface Timing Requirements ${ }^{(3)(4)(5)}$. |
| I2C1_SDA | J4 | VDD33 | $\mathrm{B}_{2}$ | Requires an external pullup to 3.3 V . The minimum acceptable pullup value is 1 $\mathrm{k} \Omega$. | I2C1_SCL | $I^{2} \mathrm{C}$ data. bidirectional, open drain signal. $I^{2} \mathrm{C}$ slave to accept command or transfer data to and from the external processor. This bus supports the frequency as specified in $P^{2} C 0$ and ${ }^{2} C 1$ Interface Timing Requirements ${ }^{(3)(4)(5)}$. |
| I2C0_SCL | M2 | VDD33 | $\mathrm{B}_{8}$ | Requires an external pullup to 3.3 V . The minimum acceptable pullup value is 1 $\mathrm{k} \Omega$. This input is not $5-\mathrm{V}$ tolerant. | N/A | $I^{2} \mathrm{C}$ Bus 0 , Clock; $I^{2} \mathrm{C}$ master for on-board peripherals such as temperature sensor. This bus supports the frequency as specified in ${ }^{2} C O$ and $F^{2} C 1$ Interface Timing Requirements ${ }^{(3)(4)(5) .}$ |
| I2C0_SDA | M3 | VDD33 | $\mathrm{B}_{8}$ | Requires an external pullup to 3.3 V . The minimum acceptable pullup value is 1 $k \Omega$. This input is not $5-\mathrm{V}$ tolerant. | I2C0_SCL | $I^{2} C$ Bus 0, Data; $I^{2} C$ master for on-board peripherals such as temperature sensor. This bus supports the frequency as specified in ${ }^{2} C O$ and $R^{2} C 1$ Interface Timing Requirements ${ }^{(3)(4)(5) .}$ |
| SYSTEM CLOCK |  |  |  |  |  |  |
| MOSC | A14 | VDD33 | $\mathrm{I}_{10}$ |  | N/A | System clock oscillator input (3.3-V LVCMOS). Note that the MOSC must be stable a maximum of 25 ms after POSENSE transitions from high to low. |
| MOSCN | A15 | VDD33 | $\mathrm{O}_{10}$ |  | N/A | MOSC crystal return |
| PORT 1: PARALLEL VIDEO/GRAPHICS INPUT ${ }^{(6)}{ }^{(7)}{ }^{(8)}$ |  |  |  |  |  |  |
| P1A_CLK | W15 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | N/A | Port 1 input data pixel write clock 'A' |
| P1B_CLK | AB17 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | N/A | Port 1 input data pixel write clock 'B' |
| P1C_CLK | Y16 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | N/A | Port 1 input data pixel write clock 'C' |
| P1_VSYNC | Y15 | VDD33 | $\begin{gathered} \mathrm{B}_{1} \\ \mathrm{H} \end{gathered}$ | Includes an internal pulldown | P1A_CLK | Port 1 vertical sync; utilizes hysteresis |
| P1_HSYNC | AB16 | VDD33 | $\begin{gathered} \mathrm{B}_{1} \\ \mathrm{H} \end{gathered}$ | Includes an internal pulldown | P1A_CLK | Port 1 horizontal sync; utilizes hysteresis |

(3) Meets $I^{2} C$ timing per the $I^{2} C$ Bus Specification, unless otherwise noted. For reference see version 2.1 of the Phillips/NXP specification.
(4) The maximum clock frequency does not account for rise time, nor added capacitance of PCB or external components which may adversely impact this value.
(5) By definition, $I^{2} \mathrm{C}$ transactions will operate at the speed of the slowest device on the bus and thus there is no requirement to match the speed grade of all devices in the system. However if Full-speed operation is desired, it will be necessary to ensure the other $I^{2} \mathrm{C}$ devices support full-speed operation as well. In addition to other devices slowing down bus operation, the length of the line (due to its capacitance) and the value of the $I^{2} \mathrm{C}$ pullup resistors will also influence the max achievable speed.
(6) Port 1 can be used to support multiple source options (e.g. HDMI, BT656) for a given product. To do so, the data bus from both source components must be connected to the same port 1 pins and control given to the DLPC350 to 3 -state the "inactive" source. Tying them together like this will cause some signal degradation due to reflections on the 3 -stated path.
(7) The A, B, and C input data channels of Port 1 can be internally swapped for optimum board layout.
(8) Sources feeding less than the full 10-bits per color component channel should be MSB justified when connected to the DLPC350 and LSBs tied off to zero. For example, an 8-bit per color input should be connected to bits $9: 2$ of the corresponding A, B, or C input channel. BT656 are 8 or 10 bits in width. If a BT656 type input is utilized, the data bits must be MSB justified as with the other types of input sources on either of the $\mathrm{A}, \mathrm{B}$, or C data input channels.

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## Pin Functions (continued)

| PIN ${ }^{(1)}$ |  | 1/0 POWER | $\begin{aligned} & \text { I/O } \\ & \text { TYPE } \end{aligned}$ | INTERNAL TERMINATION | $\begin{gathered} \text { CLK } \\ \text { SYSTEM } \end{gathered}$ | DESCRIPTION |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| NAME | NUMBER |  |  |  |  |  |
| P1_DATEN | AA16 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 data enable |
| P1_FIELD | W14 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 field sync; required for interlaced sources only (and not progressive) |
| P1_A_9 | AB20 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 A channel input pixel data (bit weight 128) |
| P1_A_8 | AA19 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 A channel input pixel data (bit weight 64) |
| P1_A_7 | Y18 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 A channel input pixel data (bit weight 32) |
| P1_A_6 | W17 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 A channel input pixel data (bit weight 16) |
| P1_A_5 | AB19 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 A channel input pixel data (bit weight 8) |
| P1_A_4 | AA18 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 A channel input pixel data (bit weight 4) |
| P1_A_3 | Y17 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 A channel input pixel data (bit weight 2) |
| P1_A_2 | AB18 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 A channel input pixel data (bit weight 1) |
| P1_A_1 | W16 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 A channel input pixel data (bit weight 0.5) |
| P1_A_0 | AA17 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 A channel input pixel data (bit weight 0.25) |
| P1_B_9 | U21 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 B channel input pixel data (bit weight 128) |
| P1_B_8 | U20 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 B channel input pixel data (bit weight 64) |
| P1_B_7 | V22 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 B channel input pixel data (bit weight 32) |
| P1_B_6 | U19 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 B channel input pixel data (bit weight 16) |
| P1_B_5 | V21 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 B channel input pixel data (bit weight 8) |
| P1_B_4 | W22 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 B channel input pixel data (bit weight 4) |
| P1_B_3 | W21 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 B channel input pixel data (bit weight 2) |
| P1_B_2 | AA20 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 B channel input pixel data (bit weight 1) |
| P1_B_1 | Y19 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 B channel input pixel data (bit weight 0.5) |
| P1_B_0 | W18 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 B channel input pixel data (bit weight 0.25) |
| P1_C_9 | P21 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 C channel input pixel data (bit weight 128) |
| P1_C_8 | P22 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 C channel input pixel data (bit weight 64) |
| P1_C_7 | R19 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 C channel input pixel data (bit weight 32) |
| P1_C_6 | R20 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 C channel input pixel data (bit weight 16) |
| P1_C_5 | R21 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 C channel input pixel data (bit weight 8) |
| P1_C_4 | R22 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 C channel input pixel data (bit weight 4) |
| P1_C_3 | T21 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 C channel input pixel data (bit weight 2) |
| P1_C_2 | T20 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 C channel input pixel data (bit weight 1) |
| P1_C_1 | T19 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 C channel input pixel data (bit weight 0.5) |
| P1_C_0 | U22 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | P1A_CLK | Port 1 C channel input pixel data (bit weight 0.25) |

PORT 2: FPD-LINK COMPATIBLE VIDEO/GRAPHICS INPUT ${ }^{(9)}$

| RCK_IN_P | Y9 | $\begin{gathered} \text { VDD33_FP } \\ \mathrm{D} \end{gathered}$ | $I_{5}$ | Includes weak internal pulldown | N/A | Positive differential input signal for Clock, FPD-Link receiver |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| RCK_IN_N | W9 | $\begin{gathered} \text { VDD33_FP } \\ \mathrm{D} \end{gathered}$ | $I_{5}$ | Includes weak internal pulldown | N/A | Negative differential input signal for Clock, FPD-Link receiver |
| RA_IN_P | AB10 | $\begin{gathered} \text { VDD33_FP } \\ \mathrm{D} \end{gathered}$ | $\mathrm{I}_{5}$ | Includes weak internal pulldown | RCK_IN | Positive differential input signal for data channel A, FPDLink receiver |
| RA_IN_N | AA10 | $\begin{gathered} \text { VDD33_FP } \\ \mathrm{D} \end{gathered}$ | $I_{5}$ | Includes weak internal pulldown | RCK_IN | Negative differential input signal for data channel A, FPD-Link receiver |
| RB_IN_P | Y11 | $\begin{gathered} \text { VDD33_FP } \\ \mathrm{D} \end{gathered}$ | $I_{5}$ | Includes weak internal pulldown | RCK_IN | Positive differential input signal for data channel B, FPDLink receiver |
| RB_IN_N | W11 | $\begin{gathered} \text { VDD33_FP } \\ \mathrm{D} \end{gathered}$ | $\mathrm{I}_{5}$ | Includes weak internal pulldown | RCK_IN | Negative differential input signal for data channel B, FPD-Link receiver |
| RC_IN_P | AB12 | $\begin{gathered} \text { VDD33_FP } \\ \mathrm{D} \end{gathered}$ | $I_{5}$ | Includes weak internal pulldown | RCK_IN | Positive differential input signal for data channel C, FPDLink receiver |

(9) Port 2 is a single-channel FPD-Link compatible input interface. FPD-Link is a defacto industry standard flat-panel display interface, which utilizes the high bandwidth capabilities of LVDS signaling to serialize video or graphics data down to a couple wires to provide a low wire count and low EMI interface. Port 2 supports sources rates up to a maximum effective clock of 90 MHz . The Port 2 input pixel data must adhere to one of four supported data mapping formats (see Table 8). Given that Port 2 inputs contain weak pulldown resistors, they can be left floating when not used.

Pin Functions (continued)

| PIN $^{(1)}$ |  | I/O | I/O <br> TYPE <br> (2) | INTERNAL TERMINATION | CLK <br> SYSTEM | DESCRIPTION |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: |
| NAME | NUMBER | AA12 | VDD33_FP <br> D | $I_{5}$ | Includes weak internal <br> pulldown | RCK_IN |
| RC_IN_N | Y13 | Vegative differential input signal for data channel C, <br> FPD-Link receiver |  |  |  |  |
| RD_IN_P | W13 | VDD33_FP <br> D | $I_{5}$ | Includes weak internal <br> pulldown | RCK_IN | Positive differential input signal for data channel D, FPD- <br> Link receiver |
| RD_IN_N | AB14 | VDD33_FP <br> D | $I_{5}$ | Includes weak internal <br> pulldown <br> pulldown | RCK_IN | Positive differential input signal for data channel E, FPD- <br> Link receiver |
| RE_IN_P | AA14 | VDD33_FP <br> D | $I_{5}$ | Includes weak internal <br> pulldown | RCK_IN | Negative differential input signal for data channel E, <br> FPD-Link receiver |
| RE_IN_N |  |  |  |  |  |  |

## DMD INTERFACE

| DMD_D0 | A8 | VDD_DMD | $\mathrm{O}_{7}$ |  | DMD_DCLK | DMD data pins. DMD data pins are double data rate (DDR) signals that are clocked on both edges of DMD_DCLK. <br> All 24 DMD data signals are use to interface to the DMD. |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DMD_D1 | B8 |  |  |  |  |  |
| DMD_D2 | C8 |  |  |  |  |  |
| DMD_D3 | D8 |  |  |  |  |  |
| DMD_D4 | B11 |  |  |  |  |  |
| DMD_D5 | C11 |  |  |  |  |  |
| DMD_D6 | D11 |  |  |  |  |  |
| DMD_D7 | E11 |  |  |  |  |  |
| DMD_D8 | C7 |  |  |  |  |  |
| DMD_D9 | B10 |  |  |  |  |  |
| DMD_D10 | E7 |  |  |  |  |  |
| DMD_D11 | D10 |  |  |  |  |  |
| DMD_D12 | A6 |  |  |  |  |  |
| DMD_D13 | A12 |  |  |  |  |  |
| DMD_D14 | B12 |  |  |  |  |  |
| DMD_D15 | C12 |  |  |  |  |  |
| DMD_D16 | D12 |  |  |  |  |  |
| DMD_D17 | B7 |  |  |  |  |  |
| DMD_D18 | A10 |  |  |  |  |  |
| DMD_D19 | D7 |  |  |  |  |  |
| DMD_D20 | B6 |  |  |  |  |  |
| DMD_D21 | E9 |  |  |  |  |  |
| DMD_D22 | C10 |  |  |  |  |  |
| DMD_D23 | C6 |  |  |  |  |  |
| DMD_DCLK | A9 | VDD_DMD | $\mathrm{O}_{7}$ |  | N/A | DMD data clock (DDR) |
| DMD_LOADB | B9 | VDD_DMD | $\mathrm{O}_{7}$ |  | DMD_DCLK | DMD data load signal (active-low) |
| DMD_SCTRL | C9 | VDD_DMD | $\mathrm{O}_{7}$ |  | DMD_DCLK | DMD data serial control signal |
| DMD_TRC | D9 | VDD_DMD | $\mathrm{O}_{7}$ |  | DMD_DCLK | DMD data toggle rate control |
| DMD_DRC_BUS | D5 | VDD_DMD | $\mathrm{O}_{7}$ |  | $\begin{gathered} \text { DMD_SAC_ } \\ \text { CLK } \end{gathered}$ | DMD reset control bus data |
| DMD_DRC_STRB | C5 | VDD_DMD | $\mathrm{O}_{7}$ |  | $\begin{gathered} \text { DMD_SAC_ } \\ \text { CLK } \end{gathered}$ | DMD reset control bus strobe |
| $\overline{\text { DMD_DRC_OE }}$ | B5 | VDD_DMD | $\mathrm{O}_{7}$ | Requires a 30 to $51-\mathrm{k} \Omega$ external pullup resistor to VDD_DMD. | Async | DMD reset control enable (active-low) |
| DMD_SAC_BUS | D6 | VDD_DMD | 07 |  | $\begin{gathered} \text { DMD_SAC_ } \\ \text { CLK } \end{gathered}$ | DMD stepped-address control bus data |
| DMD_SAC_CLK | A5 | VDD_DMD | $\mathrm{O}_{7}$ |  | N/A | DMD stepped-address control bus clock |
| DMD_PWR_EN | G20 | VDD_DMD | $\mathrm{O}_{2}$ |  | Async | DMD Power Enable control. This signal indicates to an external regulator that the DMD is powered. |
| EXRES | A3 |  | O |  | Async | DMD drive strength adjustment precision reference. $\mathrm{A} \pm$ $1 \%$ external precision resistor should be connected to this pin. |

## Pin Functions (continued)

| PIN ${ }^{(1)}$ |  |  | $\begin{array}{\|c} \hline \text { I/O } \\ \text { TYPE } \end{array}$ | INTERNAL TERMINATION | $\begin{gathered} \text { CLK } \\ \text { SYSTEM } \end{gathered}$ | DESCRIPTION |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| NAME | NUMBER |  |  |  |  |  |
| FLASH INTERFACE |  |  |  |  |  |  |
| PM_CS_1 | U2 | VDD33 | $\mathrm{O}_{2}$ |  | Async | Boot flash (active low). Required for boot memory |
| PM_CS_2 | U1 | VDD33 | $\mathrm{O}_{2}$ |  | Async | Optional for additional flash (up to 128 Mb ) |
| PM_ADDR_22 | V3 | VDD33 | $\mathrm{B}_{2}$ |  | Async | Flash memory address bit |
| PM_ADDR_21 | W1 |  |  |  |  |  |
| PM_ADDR_20 | W2 |  | $\mathrm{O}_{2}$ |  |  |  |
| PM_ADDR_19 | Y1 |  |  |  |  |  |
| PM_ADDR_18 | AB2 |  |  |  |  |  |
| PM_ADDR_17 | AA3 |  |  |  |  |  |
| PM_ADDR_16 | Y4 |  |  |  |  |  |
| PM_ADDR_15 | W5 |  |  |  |  |  |
| PM_ADDR_14 | AB3 |  |  |  |  |  |
| PM_ADDR_13 | AA4 |  |  |  |  |  |
| PM_ADDR_12 | Y5 |  |  |  |  |  |
| PM_ADDR_11 | W6 |  |  |  |  |  |
| PM_ADDR_10 | AB4 |  |  |  |  |  |
| PM_ADDR_9 | AA5 |  |  |  |  |  |
| PM_ADDR_8 | Y6 |  |  |  |  |  |
| PM_ADDR_7 | W7 |  |  |  |  |  |
| PM_ADDR_6 | AB5 |  |  |  |  |  |
| PM_ADDR_5 | AA6 |  |  |  |  |  |
| PM_ADDR_4 | Y7 |  |  |  |  |  |
| PM_ADDR_3 | AB6 |  |  |  |  |  |
| PM_ADDR_2 | W8 |  |  |  |  |  |
| PM_ADDR_1 | AA7 |  |  |  |  |  |
| PM_ADDR_0 | AB7 |  |  |  |  |  |
| PM_WE | V2 | VDD33 | $\mathrm{O}_{2}$ |  | Async | Write enable (active low) |
| PM_OE | U4 | VDD33 | $\mathrm{O}_{2}$ |  | Async | Output enable (active low) |
| PM_BLS_1 | AA8 | VDD33 | $\mathrm{O}_{2}$ |  | Async | Upper byte(15:8) enable |
| PM_BLS_0 | AB8 | VDD33 | $\mathrm{O}_{2}$ |  | Async | Lower byte(7:0) enable |
| PM_DATA_15 | M1 | VDD33 | $\mathrm{B}_{2}$ |  | Async | Data bits, upper byte |
| PM_DATA_14 | N1 |  |  |  |  |  |
| PM_DATA_13 | N2 |  |  |  |  |  |
| PM_DATA_12 | N3 |  |  |  |  |  |
| PM_DATA_11 | N4 |  |  |  |  |  |
| PM_DATA_10 | P1 |  |  |  |  |  |
| PM_DATA_9 | P2 |  |  |  |  |  |
| PM_DATA_8 | P3 |  |  |  |  |  |
| PM_DATA_7 | P4 | VDD33 | $\mathrm{B}_{2}$ |  | Async | Data bits, lower byte |
| PM_DATA_6 | R2 |  |  |  |  |  |
| PM_DATA_5 | R3 |  |  |  |  |  |
| PM_DATA_4 | R4 |  |  |  |  |  |
| PM_DATA_3 | T1 |  |  |  |  |  |
| PM_DATA_2 | T2 |  |  |  |  |  |
| PM_DATA_1 | T3 |  |  |  |  |  |
| PM_DATA_0 | T4 |  |  |  |  |  |
| LED DRIVER INTERFACE |  |  |  |  |  |  |
| HEARTBEAT | C16 | VDD33 | $\mathrm{B}_{2}$ |  | Async | LED blinks continuously (heartbeat) to indicate the system is operational. The period is one second with a $50 \%$ duty cycle. |
| FAULT_STATUS | B16 | VDD33 | $\mathrm{B}_{2}$ |  | Async | LED off indicates any system fault |

Pin Functions (continued)

| PIN ${ }^{(1)}$ |  | 1/0 POWER | I/OTYPE (2) | INTERNAL TERMINATION | $\begin{gathered} \text { CLK } \\ \text { SYSTEM } \end{gathered}$ | DESCRIPTION |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| NAME | NUMBER |  |  |  |  |  |
| LEDR_PWM | K2 | VDD33 | $\mathrm{O}_{2}$ |  | Async | LED red PWM output enable control |
| LEDG_PWM | K3 |  |  |  |  | LED green PWM output enable control |
| LEDB_PWM | K4 |  |  |  |  | LED blue PWM output enable control |
| LEDR_EN | L3 | VDD33 | $\mathrm{O}_{2}$ |  | Async | LED red PWM output |
| LEDG_EN | L4 |  |  |  |  | LED green PWM output |
| LEDB_EN | K1 |  |  |  |  | LED blue PWM output |
| TRIGGER CONTROL |  |  |  |  |  |  |
| TRIG_IN_1 | G19 | VDD33 | $\mathrm{B}_{2}$ |  | Async | In trigger mode 1, this signal is used to advance the pattern display. In trigger mode 2, the rising edge displays the pattern and the falling edge displays the next indexed pattern. |
| TRIG_IN_2 | F22 | VDD33 | $\mathrm{B}_{2}$ |  | Async | In trigger mode 1, this signal is used to start (rising edge) and stop (falling edge) the pattern display. It works along with the software start and stop command. In trigger mode 2, this signal is used to advance the pattern by two indexes. |
| TRIG_OUT_1 | C17 | VDD33 | $\mathrm{B}_{2}$ |  | Async | Active high trigger output signal during pattern exposure |
| TRIG_OUT_2 | K21 | VDD33 | $\mathrm{B}_{2}$ |  | Async | Active high trigger output to indicate first pattern display |

PERIPHERAL INTERFACE

| USB_DAT_N | E3 | VDD33 | $\mathrm{B}_{9}$ |  | Async | USB D- I/O for USB command interface. TI strongly recommends a 5.0-W external series resistance (of 22 $\Omega$ ) to limit the potential impact of a continuous short circuit between USB_DAT_N and either $V_{B U S}$, GND, the other data line, or the cable. For additional protection, an optional 200-mA Shottky diode from USB_DAT_N to VDD33 can also be added. |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| USB_DAT_P | E2 |  |  |  |  | USB D+ I/O for USB command interface. TI strongly recommends a 5.0-W external series resistance (of 22 $\Omega$ ) to limit the potential impact of a continuous short circuit between USB_DAT_P and either $V_{\text {BUS }}$, GND, the other data line, or the cable. For additional protection, an optional $200-\mathrm{mA}$ Shottky diode from USB_DAT_P to VDD33 can also be added. |
| USB_EN | C18 | VDD33 | $\mathrm{B}_{2}$ |  | Async | USB enable |
| UART_TXD | L19 | VDD33 | $\mathrm{O}_{2}$ |  | Async | Transmit data output. Reserved for debug messages |
| UART_RXD | L21 | VDD33 | $\mathrm{I}_{4}$ |  | Async | Receive data input. Reserved for debug messages |
| $\overline{\text { UART_RTS }}$ | M19 | VDD33 | $\mathrm{O}_{2}$ |  | Async | Ready to send hardware flow control output. Reserved for debug messages |
| UART_CTS | L20 | VDD33 | $I_{4}$ |  | Async | Clear to send hardware flow control input. Reserved for debug messages |
| GPIOS ${ }^{(10)}$ |  |  |  |  |  | ALTERNATIVE MODE |
| GPIO_36 | G1 | VDD33 | $\mathrm{B}_{2}$ |  | Async | None |
| GPIO_35 | H4 | VDD33 | $\mathrm{B}_{2}$ |  | Async | None |
| GPIO_34 | H3 | VDD33 | $\mathrm{B}_{2}$ |  | Async | None |
| GPIO_33 | H2 | VDD33 | $\mathrm{B}_{2}$ |  | Async | None |
| GPIO_29 | F20 | VDD33 | $\mathrm{B}_{2}$ |  | Async | None |
| GPIO_28 | E22 | VDD33 | $\mathrm{B}_{2}$ |  | Async | None |
| GPIO_27 | E21 | VDD33 | $\mathrm{B}_{2}$ |  | Async | None |
| GPIO_25 | D22 | VDD33 | $\mathrm{B}_{2}$ |  | Async | None |
| GPIO_24 | E20 | VDD33 | $\mathrm{B}_{2}$ |  | Async | None |
| GPIO_21 | N20 | VDD33 | $\mathrm{B}_{2}$ |  | Async | None |
| GPIO_20 | N19 | VDD33 | $\mathrm{B}_{2}$ |  | Async | None |
| GPIO_15 | B19 | VDD33 | $\mathrm{B}_{2}$ |  | Async | None |

(10) GPIO signals must be configured via software for input, output, bidirectional, or open-drain. Some GPIOs have one or more "alternative use" modes which are also software configurable. The reset default for all optional GPIOs is as an input signal. However, any alternate function connected to these GPIO pins with the exception of General Purpose Clocks and PWM Generation, will be reset. An external pullup to the $3.3-\mathrm{V}$ supply is required for each signal configured as open-drain. External pullup or pulldown resistors may be required to ensure stable operation before software is able to configure these ports.

## DLPC350

## Pin Functions (continued)

| PIN ${ }^{(1)}$ |  |  | $\begin{aligned} & \text { I/O } \\ & \text { TYPE } \end{aligned}$ | INTERNAL TERMINATION | $\begin{gathered} \text { CLK } \\ \text { SYSTEM } \end{gathered}$ | DESCRIPTION |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| NAME | NUMBER |  |  |  |  |  |
| GPIO_14 | B18 | VDD33 | $\mathrm{B}_{2}$ |  | Async | None |
| GPIO_13 | L2 | VDD33 | $\mathrm{B}_{2}$ |  | Async | None |
| GPIO_12 | M4 | VDD33 | $\mathrm{B}_{2}$ |  | Async | OCLKD (Output) |
| GPIO_11 | A19 | VDD33 | $\mathrm{B}_{2}$ |  | Async | OCLKC (Output) |
| GPIO_06 | A18 | VDD33 | $\mathrm{B}_{2}$ |  | Async | PWM_IN_1 (Input) |
| GPIO_05 | D16 | VDD33 | $\mathrm{B}_{2}$ |  | Async | PWM_IN_0 (Input) |
| GPIO_02 | A17 | VDD33 | $\mathrm{B}_{2}$ |  | Async | PWM_STD_2 (Output) |
| GPIO_00 | C15 | VDD33 | $\mathrm{B}_{2}$ |  | Async | PWM_STD_0 (Output) |
| OTHER INTERFACES |  |  |  |  |  |  |
| FAN_LOCKED | B17 | VDD33 | $\mathrm{B}_{2}$ |  | Async | Feedback from fan to indicate fan is connected and running |
| FAN_PWM | D15 | VDD33 | $\mathrm{B}_{2}$ |  | Async | Fan PWM speed control |

CONTROLLER MANUFACTURER TEST SUPPORT

| HW_TEST_EN | V7 | VDD33 | $\begin{aligned} & \mathrm{I}_{4} \\ & \mathrm{H} \end{aligned}$ | Includes internal pulldown | N/A | Reserved for test. Should be connected directly to ground on the PCB for normal operation |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| BOARD LEVEL TEST AND DEBUG |  |  |  |  |  |  |
| TDI | P18 | VDD33 | $\mathrm{I}_{4}$ | Includes internal pullup | TCK | JTAG serial data in. ${ }^{(11)}$ |
| TCK | R18 | VDD33 | $\mathrm{I}_{4}$ | Includes internal pullup | N/A | JTAG serial data clock. ${ }^{(11)}$ |
| TMS1 | V15 | VDD33 | $\mathrm{I}_{4}$ | Includes internal pullup | TCK | JTAG test mode select. ${ }^{(11)}$ |
| TDO1 | L18 | VDD33 | $\mathrm{O}_{1}$ |  | TCK | JTAG serial data out. ${ }^{(11)}$ |
| TRST | V17 | VDD33 | $\begin{aligned} & \mathrm{I}_{4} \\ & \mathrm{H} \end{aligned}$ | Includes internal pullup | Async | JTAG, RESET (active-low). This pin should be pulled high (or left unconnected) when the JTAG interface is in use for boundary scan. Connect this pin to ground otherwise. Failure to tie this pin low during normal operation causes startup and initialization problems. ${ }^{(11)}$ |
| RTCK | G18 | VDD33 | $\mathrm{O}_{2}$ |  | N/A | JTAG return clock. ${ }^{(12)}$ |
| ICTSEN | V6 | VDD33 | $\begin{aligned} & \mathrm{I}_{4} \\ & \mathrm{H} \end{aligned}$ | Includes internal pulldown. <br> External pulldown recommended for added protection. | Async | IC 3-State Enable (active high). Asserting high 3-states all outputs except the JTAG interface. ICTSEN and TRST should be electrically tied together to put IC pins in tri-state during JTAG boundary scan operations in case other chips exist on the board interfacing with DLPC350. |
| RESERVED PINS |  |  |  |  |  |  |
| RESERVED | $\begin{aligned} & \text { N22, M22, } \\ & \text { P19, P20 } \end{aligned}$ | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pulldown | N/A | Reserved ${ }^{(12)}$ |
| RESERVED | V16 | VDD33 | $\mathrm{I}_{4}$ | Includes an internal pullup | N/A |  |
| RESERVED | D1, J2 | VDD33 | $\mathrm{I}_{4}$ |  | N/A |  |
| RESERVED | F1, F2, G2, G3, G4 | VDD33 | $\mathrm{O}_{2}$ | Includes internal pulldown | N/A | Leave these pins unconnected ${ }^{(12)}$ |
| RESERVED | $\begin{aligned} & \text { F3, J1, } \\ & \text { M21, U3 } \end{aligned}$ | VDD33 | $\mathrm{O}_{2}$ |  | N/A |  |
| RESERVED | $\begin{gathered} \text { H20, M18, } \\ \text { M20 } \end{gathered}$ | VDD33 | $\mathrm{O}_{1}$ |  | N/A |  |
| RESERVED | $\begin{aligned} & \text { H21, H22, } \\ & \text { J19, J20, } \\ & \text { J21, J22, } \\ & \text { K19, K20 } \end{aligned}$ | VDD33 | $B_{2}$ | Includes internal pulldown | N/A | Reserved ${ }^{(12)}$ |
| RESERVED | C1, D2, F4 | VDD33 | $\mathrm{B}_{2}$ |  | N/A |  |

(11) All JTAG signals are LVCMOS compatible.
(12) See General Handling Guidelines for Unused CMOS-Type Pins in the Layout section for instructions on handling unused pins.

## Table 1. Power and Ground Pin Descriptions

| POWER GROUP | PIN NUMBER | DESCRIPTION |
| :---: | :---: | :---: |
| PLLM_VSS | B15 | Master clock generator PLL ground return |
| PLLM_VDD | E14 | 1.2-V master clock generator PLL digital power ${ }^{(1)}$ |
| PLLM_VAD | D14 | 1.8-V master clock generator PLL analog power ${ }^{(1)}$ |
| PLLM_VAS | C14 | Master clock generator PLL ground return |
| PLLD_VSS | B14 | DDR clock generator PLL ground return |
| PLLD_VDD | E13 | 1.2-V DDR clock generator PLL digital power |
| PLLD_VAD | D13 | 1.8-V DDR clock generator PLL analog power ${ }^{(1)}$ |
| PLLD_VAS | C13 | DDR clock generator PLL ground return |
| VSS | E5, D4, C3, B2, A2, N6, F11, J9, J10, J11, J12, J13, J14, K9, K10, K11, K12, K13, K14, L9, L10, L11, L12, L13, L14, M9, M10, M11, M12, M13, M14, N9, N10, N11, N12, N13, N14, P9, P10, P11, P12, P13, P14, H1, B1, C2, D3, E4, V5, W4, Y3, AA1, AA2, U8, U15, A21, A22, B21, B22, C20, D19, E18, V18, W19, Y20, AA21, AB22, M17, C22, C21, D20, E19, K22, L22, V19, V20, W20, Y21, R1, Y2, W3, V4, F9, A7, B3, B4, C4, A13, B13, B20, C19, Y14, Y12, W12, W10, Y10, AA13, AB13, AA11, AB11, Y8, AA9, F14, V14, V8 | Common Ground (105) |
| VDDC | F12, F7, F6, G6, M6, F5, G5, M5, U6, U7, F17, G17, U16, U17, F18, N17, U18, U5, F16, E6, E12, E17, K6, L6, P6, R6, K17, L17, P17, R17 | Core 1.2-V Power |
| VDD33 | AB1, F15, T5, T6, AA22, H6, J6, L1, E1, H5, J5, K5, L5, N5, P5, U9, U14, H17, J17, T17, Y22, T22, G22, H18, J18, N18, R5, V1, A20, A16, E15, V9, AA15, AB15, AB21, AB9, T18, K18, F13 | LVCMOS I/O 3.3-V Power |
| VDD_DMD | F10, F8, A4, A11, E8, E10 | 1.9-V DMD interface voltage |
| VDD12_FPD | U11, U12, V12, V11 | FPD-Link LVDS interface 1.2-V power ${ }^{(1)}$ |
| VDD33_FPD | U10, U13, V13, V10 | FPD-Link LVDS interface 3.3-V power ${ }^{(1)}$ |
| Spare | E16 | TI recommends that this signal be tied to ground via an external pulldown resistor |
| VPGM | D17 | Fuse programming pin (for manufacturing use only); this signal should be tied directly to ground for normal operation |

(1) Special filter is required for proper operation. See Recommended DLPC350 PLL Layout Configuration.

## DLPC350

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted). ${ }^{(1)}$

|  |  | MIN | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: |
|  | VDDC (Core 1.2-V Power) | -0.5 | 1.7 | V |
|  | VDD33 | -0.5 | 3.8 | V |
|  | VDD_DMD | -0.5 | 2.3 | V |
|  | VDD12_FPD | -0.5 | 1.7 | V |
| Supply Voltage ${ }^{(2)}{ }^{(3)}$ | VDD33_FPD | -0.5 | 3.8 | V |
|  | VDD12_PLLD | -0.5 | 1.7 | V |
|  | VDD12_PLLM | -0.5 | 1.7 | V |
|  | VDD_18_PLLD | -0.5 | 2.3 | V |
|  | VDD_18_PLLM | -0.5 | 2.3 | V |
|  | USB | -1.00 | 5.25 | V |
|  | OSC | -0.3 | 3.6 | V |
| Input Voltage $\left(\mathrm{V}_{\mathrm{I}}\right)^{(4)}$ | LVCMOS | -0.5 | 3.6 | V |
|  | $\mathrm{I}^{2} \mathrm{C}$ | -0.5 | 3.6 | V |
|  | LVDS | -0.5 | 3.6 | V |
|  | USB | -1.00 | 5.25 | V |
|  | DMD LPDDR | -0.3 | 2.0 | V |
| utput Voltage (V) | LVCMOS | -0.5 | 3.6 | V |
|  | $\mathrm{I}^{2} \mathrm{C}$ | -0.5 | 3.6 | V |
| $\mathrm{T}_{\mathrm{J}}$ | Junction temperature | 0 | 105 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {stg }}$ | Storage temperature | -40 | 125 | 응 |

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) All voltages referenced to VSS (ground).
(3) All of the $3.3-\mathrm{V}, 1.9-\mathrm{V}, 1.8-\mathrm{V}$, and $1.2-\mathrm{V}$ power should be applied and removed per the procedure defined in System Power and Reset.
(4) Applies to external input and bidirectional buffers.

### 6.2 ESD Ratings

|  |  |  | VALUE | UNIT |
| :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {ESD }}{ }^{(1)}$ | Electrostatic discharge immunity | Human body model (HBM) ${ }^{(2)}$ | $\pm 2000$ | V |
|  |  | Charged device model (CDM) ${ }^{(3)}$ | $\pm 500$ |  |

(1) Electrostatic discharge (ESD) to measure device sensitivity and immunity to damage caused by assembly line electrostatic discharges in to the device.
(2) Level listed above is the passing level per ANSI, ESDA, and JEDEC JS-001. JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(3) Level listed above is the passing level per EIA-JEDEC JESD22-C101. JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

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### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted). The functional performance of the device specified in this data sheet is achieved when operating the device by the Recommended Operating Conditions. No level of performance is implied when operating the device above or below the Recommended Operating Conditions limits.

|  |  | MIN | NOM | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| VDD33 | 3.3 V supply voltage, $\mathrm{I} / \mathrm{O}$ | 3.135 | 3.300 | 3.465 | V |
| VDD_DMD | 1.9 V supply voltage, I/O | 1.8 | 1.9 | 2.0 |  |
| VDD_18_PLLD | 1.8 V supply voltage, PLL analog | 1.71 | 1.80 | 1.89 |  |
| VDD_18_PLLM | 1.8 V supply voltage, PLL analog | 1.71 | 1.80 | 1.89 |  |
| VDD12 | 1.2 V supply voltage, core logic | 1.116 | 1.200 | 1.26 |  |
| VDD12_PLLD | 1.2 V supply voltage, PLL digital | 1.116 | 1.200 | 1.26 |  |
| VDD12_PLLM | 1.2 V supply voltage, PLL digital | 1.116 | 1.200 | 1.26 |  |
|  | USB | 0 |  | VDD33 |  |
|  | OSC | 0 |  | VDD33 |  |
| $\mathrm{V}_{1}$ | 3.3-V LVCMOS | 0 |  | VDD33 | V |
|  | $3.3-\mathrm{V} \mathrm{I}^{2} \mathrm{C}$ | 0 |  | VDD33 |  |
|  | 3.3-V LVDS | 0.6 |  | 2.2 |  |
|  | USB | 0 |  | VDD33 |  |
|  | 3.3-V LVCMOS | 0 |  | VDD33 | V |
| , | $3.3-\mathrm{V} \mathrm{I}^{2} \mathrm{C}$ | 0 |  | VDD33 | V |
|  | 1.9-V LPDDR | 0 |  | VDD_DMD |  |
| TJ | Operating junction temperature | 0 |  | 105 | ${ }^{\circ} \mathrm{C}$ |

### 6.4 Thermal Information

|  | THERMAL METRIC | DLPC350 | UNIT |
| :---: | :---: | :---: | :---: |
|  |  | BGA (ZFF) |  |
|  |  | 419 PINS |  |
| $\mathrm{R}_{\text {өJC }}{ }^{(1)}$ | Junction-to-case thermal resistance | 6.6 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{R}_{\theta \text { JA }}$ at $0 \mathrm{~m} / \mathrm{s}$ of forced airflow ${ }^{(2)}$ | Junction-to-air thermal resistance | 19.4 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{R}_{\theta \mathrm{JA}}$ at $1 \mathrm{~m} / \mathrm{s}$ of forced airflow ${ }^{(2)}$ | Junction-to-air thermal resistance | 16.7 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{R}_{\theta \mathrm{JA}}$ at $2 \mathrm{~m} / \mathrm{s}$ of forced airflow ${ }^{(2)}$ | Junction-to-air thermal resistance | 15.8 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\varphi_{\mathrm{jt}}{ }^{(3)}$ | Temperature variance from junction to package top center temperature, per unit power dissipation | 0.33 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

(1) $R_{\theta J C}$ analysis assumptions: The heat generated in the chip flows both into over-mold (top side) and into the package laminate (bottom side) and then into the PCB via package solder balls. This should be used for heat sink analysis only.
(2) Thermal coefficients abide by JEDEC Standard $51 . R_{\theta J A}$ is the thermal resistance of the package as measured using a JEDEC defined standard test PCB. This JEDEC test PCB is not necessarily representative of the DLPC350 PCB and thus the reported thermal resistance may not be accurate in the actual product application. Although the actual thermal resistance may be different, it is the best information available during the design phase to estimate thermal performance.
(3) Example: ( 3 W ) $\times\left(0.33^{\circ} \mathrm{C} / \mathrm{W}\right)=$ approximately a $1.00^{\circ} \mathrm{C}$ temperature rise.

## DLPC350

DLPS029D -APRIL 2013-REVISED AUGUST 2016
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### 6.5 I/O Electrical Characteristics

Voltage and current characteristics for each I/O type signal. All inputs and outputs are LVCMOS. Over operating free-air temperature range (unless otherwise noted).

| PARAMETER ${ }^{(1)}$ |  |  | TEST | MIN | NOM MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{IH}}$ | High-level input voltage | USB (9) |  | 2.0 |  | V |
|  |  | OSC (10) |  | 2.0 |  |  |
|  |  | 3.3-V LVCMOS (1, 2, 3, 4) |  | 2.0 |  |  |
|  |  | $3.3-\mathrm{V} \mathrm{I}^{2} \mathrm{C}$ (8) |  | 2.4 |  |  |
| $\mathrm{V}_{\text {IL }}$ | Low-level input voltage | USB (9) |  |  | 0.8 | V |
|  |  | OSC (10) |  |  | 0.8 |  |
|  |  | 3.3-V LVCMOS (1, 2, 3, 4) |  |  | 0.8 |  |
|  |  | $3.3-\mathrm{V} \mathrm{I}^{2} \mathrm{C}$ |  |  | 1.0 |  |
| $\mathrm{V}_{\mathrm{OH}}$ | High-level output voltage | USB (9) |  | 2.8 |  | V |
|  |  | 3.3-V LVCMOS (1,2,3) | $\mathrm{I}_{\mathrm{OH}}=$ Max Rated | 2.8 |  |  |
|  |  | 1.9-V DMD LPDDR (7) | $\mathrm{I}_{\mathrm{OH}}=-0.1 \mathrm{~mA}$ | $\begin{array}{r} 0.9 \times \\ \operatorname{VDD} D^{D} \\ M D \end{array}$ |  |  |
| $\mathrm{V}_{\text {OL }}$ | Low-level output voltage | USB (9) |  |  | 0.3 | V |
|  |  | 3.3-V LVCMOS (1, 2, 3) | $\mathrm{I}_{\mathrm{OL}}=$ Max Rated |  | 0.4 |  |
|  |  | 1.9-V DMD LPDDR (7) | $\mathrm{l}_{\mathrm{OL}}=+0.1 \mathrm{~mA}$ |  | $\begin{array}{r} 0.1 \times \\ \operatorname{VDD} D^{\mathrm{D}} \\ \mathrm{MD} \end{array}$ |  |
|  |  | $3.3-\mathrm{V} \mathrm{I}^{2} \mathrm{C}$ (8) | $\mathrm{I}_{\mathrm{OL}}=3 \mathrm{~mA}$ sink |  | 0.4 |  |
| $\mathrm{V}_{\text {IDTH }}$ | Input differential threshold | 3.3-V LVDS (5) |  | -200 | 200 | mV |
| \| $\mathrm{V}_{\text {ID }} \mid$ | Absolute input differential voltage | USB (9) |  | 200 |  | mV |
|  |  | 3.3-V LVDS (5) |  | 200 | 600 |  |
| VICM | Input Common Mode Voltage Range | USB (9) |  | 0.8 | 2.5 | V |
|  |  | 3.3-V LVDS (5) | At MIN absolute input differential voltage | 0.7 | 2.1 |  |
|  |  | 3.3-V LVDS (5) | At MAX absolute input differential voltage | 0.9 | 1.9 |  |
| $\mathrm{V}_{\mathrm{HYS}}$ | Hysteresis ( $\mathrm{V}_{\left.\mathrm{T}_{+}-\mathrm{V}_{\mathrm{T}-}\right)}$ | 3.3-V LVCMOS (1, 2, 3, 4) |  |  | 400 | mV |
|  |  | $3.3-\mathrm{V} \mathrm{I}^{2} \mathrm{C}$ (8) |  |  | 550 |  |
|  |  | USB (9) |  |  | 320 |  |
| $\mathrm{R}_{1}$ | Receiver input impedance | 3.3-V LVDS (5) | $\mathrm{VDDH}=3.3 \mathrm{~V}$ | 90 | 110132 | $\Omega$ |
| $\mathrm{I}_{\mathrm{H}}$ | High-level input current (IPD = internal pulldown) | USB (9) |  |  | 10 | $\mu \mathrm{A}$ |
|  |  | OSC (10) |  |  | 10 |  |
|  |  | 3.3-V LVCMOS (1, 2, 3, 4) without IPD | $\mathrm{V}_{\mathrm{IH}}=\mathrm{VDD} 33$ |  | 10 |  |
|  |  | 3.3-V LVCMOS (1, 2, 3, 4) with IPD | $\mathrm{V}_{\mathrm{IH}}=\mathrm{VDD} 33$ |  | 200 |  |
|  |  | $3.3-\mathrm{V} \mathrm{I}^{2} \mathrm{C}$ (8) | $\mathrm{V}_{\mathrm{IH}}=$ VDD33 |  | 10 |  |
| $\mathrm{I}_{\text {IL }}$ | Low-level input current(IPU = internal pullup) | USB (9) |  |  | -10 | $\mu \mathrm{A}$ |
|  |  | OSC (10) |  |  | -10 |  |
|  |  | 3.3-V LVCMOS (1, 2, 3, 4) without IPU | $\mathrm{V}_{\mathrm{OH}}=\mathrm{VDD} 33$ |  | -10 |  |
|  |  | 3.3-V LVCMOS (1, 2, 3, 4) with IPU | $\mathrm{V}_{\mathrm{OH}}=\mathrm{VDD} 33$ |  | -200 |  |
|  |  | 3.3-V 1² ${ }^{2}$ (8) | $\mathrm{V}_{\mathrm{OH}}=$ VDD33 |  | -10 |  |

(1) Numbers in parentheses correspond with I/O Type Definition.

## I/O Electrical Characteristics (continued)

Voltage and current characteristics for each I/O type signal. All inputs and outputs are LVCMOS. Over operating free-air temperature range (unless otherwise noted).

| PARAMETER ${ }^{(1)}$ |  |  | TEST CONDITIONS | MIN | NOM | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{IOH}^{\text {r }}$ | High-level output current | USB (9) |  | 17.08 |  |  | mA |
|  |  | 1.9-V DMD LPDDR (7) | $\mathrm{V}_{\mathrm{O}}=1.5 \mathrm{~V}$ | -4.0 |  |  |  |
|  |  | 3.3-V LVCMOS (1) | $\mathrm{V}_{\mathrm{O}}=2.4 \mathrm{~V}$ | -4.0 |  |  |  |
|  |  | 3.3-V LVCMOS (2) | $\mathrm{V}_{\mathrm{O}}=2.4 \mathrm{~V}$ | -8.0 |  |  |  |
|  |  | 3.3-V LVCMOS (3) | $\mathrm{V}_{\mathrm{O}}=2.4 \mathrm{~V}$ | -12.0 |  |  |  |
| $\mathrm{IOL}^{\text {L }}$ | Low-level output current | USB (9) |  | -17.08 |  |  | mA |
|  |  | 1.9-V DMD LPDDR (7) | $\mathrm{V}_{\mathrm{O}}=0.4 \mathrm{~V}$ | 4.0 |  |  |  |
|  |  | 3.3-V LVCMOS (1) | $\mathrm{V}_{\mathrm{O}}=0.4 \mathrm{~V}$ | 4.0 |  |  |  |
|  |  | 3.3-V LVCMOS (2) | $\mathrm{V}_{\mathrm{O}}=0.4 \mathrm{~V}$ | 8.0 |  |  |  |
|  |  | 3.3-V LVCMOS (3) | $\mathrm{V}_{\mathrm{O}}=0.4 \mathrm{~V}$ | 12.0 |  |  |  |
|  |  | 3.3-V ${ }^{2} \mathrm{C}$ (8) |  | 3.0 |  |  |  |
| l Oz | High-impedance leakage current | USB (9) |  | -10 |  | 10 | $\mu \mathrm{A}$ |
|  |  | 3.3-V LVCMOS (1, 2, 3) |  | -10 |  | 10 |  |
|  |  | 3.3-V I²C (8) |  | -10 |  | 10 |  |
| $\mathrm{C}_{1}$ | Input capacitance (including package) | USB (9) |  | 11.3 | 12.8 | 14.7 | pF |
|  |  | 3.3-V LVCMOS (2) |  | 2.8 | 3.3 | 4.0 |  |
|  |  | 3.3-V LVCMOS (4) |  | 2.7 | 3.4 | 4.2 |  |
|  |  | 3.3-V I ${ }^{2} \mathrm{C}$ (8) |  | 3.0 | 3.2 | 3.5 |  |

Table 2. I/O Type Definition

| I/O |  |
| :---: | :---: |
| (NUMBER) | DEFINITION |
| 1 | $3.3-\mathrm{V}$ LVCMOS I/O buffer, with 4-mA drive |
| 2 | $3.3-\mathrm{V}$ LVCMOS I/O buffer, with 8-mA drive |
| 3 | $3.3-\mathrm{V}$ LVCMOS I/O buffer, with 12-mA drive |
| 4 | $3.3-\mathrm{V}$ LVCMOS receiver |
| 5 | $3.3-\mathrm{V}$ LVDS receiver (FPD-Link interface) |
| 6 | N/A |
| 7 | 1.9-V LPDDR output buffer (DMD interface) |
| 8 | $3.3-\mathrm{V}$ I $^{2} \mathrm{C}$ with 12-mA sink |
| 9 | USB compatible (3.3 V) |
| 10 | OSC 3.3-V I/O compatible LVCMOS |

## $6.6 I^{2} \mathrm{CO}$ and $\mathrm{I}^{2} \mathrm{C} 1$ Interface Timing Requirements ${ }^{(1)(2)(3)}$

|  |  |  | MIN | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{f}_{\text {clock }}$ | Clock frequency, HOST_1 ${ }^{2} \mathrm{C}$ _SCL | Fast-Mode |  | $400^{(4)}$ | kHz |
|  | (50\% reference points) | Standard Mode |  | $100^{(4)}$ | kHz |

[^0]
### 6.7 Port 1 Input Pixel Interface Timing Requirements

See Figure 1

| PARAMETER |  |  | MIN | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $f_{\text {(clock) }}$ | Clock frequency, P1A_CLK |  | 12 | 150 | MHz |
| $\mathrm{t}_{\mathrm{c}}$ | Cycle time, P1A_CLK |  | 6.666 | 83.330 | ns |
| $\mathrm{t}_{\mathrm{jp}}$ | Clock jitter, P1A_CLK (deviation in period from ideal) ${ }^{(1)}$ | Maximum $f_{\text {(clock) }}$ |  |  |  |
| $\mathrm{t}_{\mathrm{w}(\mathrm{L})}$ | Pulse duration low, P1A_CLK | 50\% reference points | 2.3 |  | ns |
| $\mathrm{t}_{\mathrm{w} \text { (H) }}$ | Pulse duration high, P1A_CLK | 50\% reference points | 2.3 |  | ns |
| $\mathrm{t}_{\text {su }}$ | Setup time - P1_(A-C)(9-0), P1_VSYNC, P1_HSYNC, P1_FIELD, P1_DATEN; Valid before P1A_CLK $\uparrow \downarrow$ | 50\% reference points | 3 |  | ns |
| $t_{\text {h }}$ | Hold time - P1_(A-C)(9-0), P1_VSYNC, P1_HSYNC, P1_FIELD, P1_DATEN; Valid after P1A_CLK $\uparrow \downarrow$ | 50\% reference points | 3 |  | ns |
| $t_{t}$ | Transition time - P1A_CLK | 20\% to $80 \%$ reference points | 0.6 | 2.0 | ns |
| $t_{t}$ | Transition time - P1_A(9-0), P1_B(9-0), P1_C(9-0), P1_HSYNC, P1_VSYNC, P1_DATEN | 20\% to $80 \%$ reference points | 0.6 | 3.0 | ns |

(1) For frequencies ( $\mathrm{f}_{\text {clock }}$ ) less than 150 MHz , clock jitter (in ns) should be calculated using this formula: Max Clock Jitter $= \pm$ [1/ $\mathrm{f}_{\text {clock }}-$ 5414 ps].

### 6.8 Port 2 Input Pixel Interface (FPD-Link Compatible LVDS Input) Timing Requirements

See Figure 2, Figure 3 and Figure 4

| PARAMETER ${ }^{(1)}$ |  | MIN | MAX |
| :--- | :--- | ---: | :---: |
| UNIT |  |  |  |
| $f_{\text {clock }}$ | Clock frequency, P2_CLK (LVDS input clock) | 20 |  |
| $\mathrm{t}_{\mathrm{c}}$ | Cycle time, P2_CLK (LVDS input clock) | 90 | MHz |
| $\mathrm{t}_{\text {slew }}$ | Clock or data slew rate | $f_{\text {pxck }}<90 \mathrm{MHz}$ | 11.1 |
|  | $f_{\text {pxck }}>90 \mathrm{MHz}$ | 0.3 | ns |
| $\mathrm{t}_{\text {startup }}$ Link startup time (internal) | 0.5 |  |  |

(1) Extra Notes:
(a) Minimize cross-talk and match traces on PCB as close as possible.
(b) TI recommends to keep the common mode voltage as close to 1.2 V as possible.
(c) Tl recommends to keep the absolute input differential voltage as high as possible.
(d) The LVDS open input detection is only related to a low common mode voltage; it is not related to a low differential swing.
(e) LVDS power 3.3-V supply (VDD33_FPD) noise level should be below 100 mV p-p.
(f) LVDS power 1.2-V supply (VDD12_FPD) noise level should be below 60 mV p-p.

### 6.9 System Oscillator Timing Requirements

See Figure 5

| PARAMETER |  |  | MIN | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $f_{\text {clock }}$ | Clock frequency, MOSC ${ }^{(1)}$ |  | 31.9968 | 32.0032 | MHz |
| $\mathrm{t}_{\mathrm{c}}$ | Cycle time, MOSC ${ }^{(1)}$ |  | 31.188 | 31.256 | ns |
| $\mathrm{t}_{\mathrm{w}(\mathrm{H})}$ | Pulse duration (high), MOSC ${ }^{(2)}$ | 50\% reference points | 12.5 |  | ns |
| $\mathrm{t}_{\mathrm{w}(\mathrm{L})}$ | Pulse duration (low), MOSC ${ }^{(2)}$ |  | 12.5 |  | ns |
| $t_{t}$ | Transition time, MOSC ${ }^{(2)}$ | 20\% to $80 \%$ reference points |  | 7.5 | ns |
| Period jitter, MOSC ${ }^{(2)}$ (Deviation in period from ideal period solely due to high frequency jitter and not spectrum clocking) |  |  | -100 | +100 | ps |

(1) The frequency range for MOSC is 32 MHz with $\pm 100 \mathrm{PPM}$ accuracy. This shall include impact to accuracy due to aging, temperature and trim sensitivity. The MOSC input cannot support spread spectrum clock spreading.
(2) Applies only when driven via an external digital oscillator.

### 6.10 Reset Timing Requirements

| PARAMETER |  |  | MIN | MAX |
| :--- | :--- | :--- | :---: | :---: |
| $t_{w 1(L)}$ | Pulse duration, inactive low, PWRGOOD | $50 \%$ reference points | 4 |  |
| $t_{t 1}$ | Transition time, PWRGOOD | $20 \%$ to $80 \%$ reference points |  |  |
| $t_{w 2(L)}$ | Pulse duration, inactive low, POSENSE | $50 \%$ reference points |  |  |
| $t_{t 2}$ | Transition time, POSENSE | $20 \%$ to $80 \%$ reference points | 500 |  |
| $t_{\text {PH }}$ | Power hold time, POSENSE remains active after <br> PWRGOOD is de-asserted | $20 \%$ to $80 \%$ reference points | $\mu \mathrm{s}$ |  |



Figure 1. Port 1 Input Pixel Timing


Figure 2. LVDS Timing Diagram


Figure 3. (LVDS) Link Start-up Timing


Figure 4. (LVDS) Clock: Data Skew Definition


Figure 5. System Oscillators Timing

## DLPC350

### 6.11 Video Timing Input Blanking Specification

The DLPC350 controller requires a minimum horizontal and vertical blanking for both Port 1 and Port 2. These parameters indicate the time allocated to retrace the signal at the end of each line and field of a display. For the related parameter definitions, see Video Timing Parameter Definitions.

### 6.11.1 Source Input Blanking

The vertical and horizontal blanking requirements for both input ports are defined in Table 3, except when using a 120 Hz source. In this case, please use the source input blanking timing found in Table 4. Refer to the video timing parameter definitions listed in Video Timing Parameter Definitions. Also, see Figure 7 for Parallel I/F Frame Timing.

Table 3. Source Input Blanking Requirements

| PORT | PARAMETER | MINIMUM BLANKING |
| :---: | :---: | :---: |
| Port 1 Vertical Blanking | VBP (tp_vbp) | $370 \mu \mathrm{~s}$ |
|  | VFP (tp_vfp) | 2 lines |
|  | Total vertical blanking | $370 \mu \mathrm{~s}+3$ lines |
|  | VSYNC high (tp_vsw) | 1 line |
|  | VBP (tp_vbp) | $370 \mu \mathrm{~s}$ |
|  | VFP (tp_vfp) | 0 lines |
| Port 1 and 2 Horizontal <br> Blanking | Total vertical blanking | $370 \mu \mathrm{~s}+3$ lines |
|  | VSYNC high (tp_vsw) | 1 line |
|  | HBP (tp_hbp) | 10 pixels |
|  | Total horizontal blanking for 0.45 WXGA DMD | 0 pixels |
|  | HSYNC high (tp_hsw) | $154286 \div$ Source APPL pixels (round up) |

Table 4. 120 Hz Source Input Blanking Timings on Port 1

| PORT | PARAMETER | MINIMUM BLANKING |
| :---: | :---: | :---: |
| Vertical Blanking | VBP (tp_vbp) | 3 lines |
|  | VFP (tp_vfp) | 17 lines |
|  | Total vertical blanking | 30 lines |
|  | VSYNC high (tp_vsw) | 10 lines |
| Horizontal Blanking | HBP (tp_hbp) | 10 pixels |
|  | HFP (tp_hfp) | 56 pixels |
|  | Total horizontal blanking | 128 pixels |
|  | HSYNC high (tp_vsw) | 64 pixels |
| Pixel Clock |  | 146.0 MHz |



Figure 6. Horizontal and Vertical Blanking Diagram


Figure 7. Parallel I/F Frame Timing

## DLPC350

DLPS029D -APRIL 2013-REVISED AUGUST 2016
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### 6.12 Programmable Output Clocks Switching Characteristics

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | MIN | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $f_{\text {clock }} \quad$ Clock frequency, OCLKC ${ }^{(1)}$ | N/A | OCLKC | 0.7759 | 48 | MHz |
| $\mathrm{t}_{\mathrm{c}} \quad$ Cycle time, OCLKC ${ }^{(2)}$ | N/A | OCLKC | 20.83 | 1288.80 | ns |
| $\mathrm{t}_{\mathrm{w}(\mathrm{L})} \quad$ Pulse duration low (50\% reference points) | N/A | OCLKC | $\left(t_{c} / 2\right)-2$ |  | ns |
| $\mathrm{t}_{\mathrm{w}(\mathrm{H})} \quad$ Pulse duration high (50\% reference points) | N/A | OCLKC | $\left(t_{c} / 2\right)-2$ |  | ns |
| $f_{\text {clock }}$ Clock frequency, OCLKD ${ }^{(1)}$ | N/A | OCLKD | 0.7759 | 48 | MHz |
| $\mathrm{t}_{\mathrm{c}} \quad$ Cycle time, OCLKD ${ }^{(2)}$ | N/A | OCLKD | 20.83 | 1288.80 | ns |
| $\mathrm{t}_{\mathrm{w}(\mathrm{L})} \quad$ Pulse duration low (50\% reference points) | N/A | OCLKD | $\left(t_{c} / 2\right)-2$ |  | ns |
| $\mathrm{t}_{\mathrm{w}(\mathrm{H})} \quad$ Pulse duration high (50\% reference points) | N/A | OCLKD | $\left(t_{c} / 2\right)-2$ |  | ns |

(1) The frequency of OCLKC and OCLKD is programmable. See GPIO pins 11 and 12.
(2) The duty cycle of OCLKC and OCLKD will be within $\pm 2 \mathrm{~ns}$ of $50 \%$.


Figure 8. Programmable Output Clocks Timing Diagram

### 6.13 DMD Interface Switching Characteristics

The DLPC350 controller DMD interface is comprised of a combination of both single data rate (SDR) and double data rate (DDR), and output signals using LPDDR (as defined by JESD209A). SDR signals are referenced to DMD_SAC_CLK and DDR signals are referenced to DMD_DCLK.
Switching characteristics over recommended operating conditions, $C_{L}$ (minimum timing) $=5 \mathrm{pF}, \mathrm{C}_{\mathrm{L}}$ (maximum timing) $=25 \mathrm{pF}$ (unless otherwise noted).

|  | PARAMETER | TEST CONDITIONS | FROM (INPUT) | TO (OUTPUT) | MIN | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $f_{\text {clock } 1}$ | Clock frequency ${ }^{(1)(2)}$ |  | N/A | DMD_DCLK | 79.992 | 120.012 | MHz |
| $\mathrm{t}_{\text {p1_clkper }}$ | Clock period | 50\% reference points | N/A | DMD_DCLK | 8.332 | 12.502 | ns |
| $\mathrm{t}_{\text {p1_ }} \mathrm{cwh}$ | Clock pulse duration low | 50\% reference points | N/A | DMD_DCLK | 3.75 |  | ns |
| $\mathrm{t}_{\mathrm{p} 1} \mathrm{cwl}$ | Clock pulse duration high | 50\% reference points | N/A | DMD_DCLK | 3.75 |  | ns |
| $f_{\text {clock2 }}$ | Clock frequency ${ }^{(2)}$ |  | N/A | DMD_SAC_CLK | 74.659 | 74.675 | MHz |
| $\mathrm{t}_{\text {p2_clikper }}$ | Clock period | 50\% reference points | N/A | DMD_SAC_CLK | 13.391 | 13.394 | ns |
| $\mathrm{t}_{\mathrm{p} 2}$ cwh | Clock pulse duration low | 50\% reference points | N/A | DMD_SAC_CLK | 6 |  | ns |
| $\mathrm{t}_{\text {p2_cwl }}$ | Clock pulse duration high | 50\% reference points | N/A | DMD_SAC_CLK | 6 |  | ns |
| $\mathrm{t}_{\text {slew }}$ | Slew rate ${ }^{(3)}{ }^{(4)(5)}$ |  | N/A | All | 0.7 |  | V/ns |
| $\mathrm{t}_{\text {p1_su }}$ | Output setup time ${ }^{(6)}$ | 50\% reference points | Both rising and falling edges of DMD_DCLK | DMD_D(23:0), <br> DMD_SCTRL, <br> DMD_LOADB, <br> DMD_TRC |  | 1.1 | ns |
| $\mathrm{t}_{\text {p1_h }}$ | Output hold time ${ }^{(6)}$ | 50\% reference points | Both rising and falling edges of DMD_DCLK | $\begin{aligned} & \text { DMD_D(23:0), } \\ & \text { DMD_SCTRL, }, \text {, } \\ & \hline \text { DMD_LOADB, } \\ & \text { DMD_TRC } \end{aligned}$ |  | 1.1 | ns |
| $\mathrm{t}_{\text {p1_skew }}$ | DMD data skew | 50\% reference points | Relative to each other | DMD_D(23:0), DMD SCTRL, DMD_LOADB, DMD_TRC, DMD_DCLK |  | 0.2 | ns |
| $\mathrm{t}_{\text {p2_su }}$ | Output setup time ${ }^{(6)}$ | 50\% reference points | Rising edge of DMD_SAC_CLK | DMD_SAC_BUS, DMD_DRC_OE, DMD_DRC_BUS, DMD_DRC_STRB |  | 2.35 | ns |
| $\mathrm{t}_{\text {p2_h }}$ | Output hold time ${ }^{(6)}$ | 50\% reference points | Rising edge of DMD_SAC_CLK | DMD SAC BUS, DMD_DRC_OE, DMD_DRC_BUS, DMD_DRC_STRB |  | 2.35 |  |
| $\mathrm{t}_{\text {p2_skew }}$ | DRC/SAC data skew | 50\% reference points | Relative to each other | DMD SAC BUS, DMD DRC OE, DMD_DRC_BUS, DMD_DRC_STRB, DMD_SAC_CLK |  | 0.2 | ns |

(1) The controller supports a fixed number of programmable clock rates with the min and max values as shown. The performance may be further limited by interface voltage and PCB routing.
(2) Note that these values do not include any tolerance variation of the external crystal or oscillator, nor do they include any associated jitter.
(3) LPDDR slew rate for the rising edge is measured between $\operatorname{VILD}(D C)$ to $\operatorname{VIHD}(A C)$ where $\operatorname{VILD}(D C)=0.3 \times \operatorname{VDDQ}$ and $\operatorname{VILD}(A C)=0.8 \times$ VDDQ.
(4) LPDDR slew rate for the rising edge is measured between $\operatorname{VILD}(\mathrm{DC})$ to $\operatorname{VIHD}(\mathrm{AC})$ where $\operatorname{VILD}(\mathrm{DC})=0.7 \times \operatorname{VDDQ}$ and $\operatorname{VILD}(\mathrm{AC})=0.2 \times$ VDDQ.
(5) The DMD setup and hold time window must be de-rated by 300 ps for each $0.1 \mathrm{~V} / \mathrm{ns}$ reduction in slew rate below $1 \mathrm{~V} / \mathrm{ns}$. Thus a 0.7 V/ns slew rate increases this window by 900 ps from 1400 to 2300 ps.
(6) Output setup and hold values already include clock jitter, DCD, SSO, ISI noise, and PCB variation. Only routing skew and DMD setup and hold need to be considered in system timing analysis.


Figure 9. DMD Interface Timing

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### 6.14 JTAG Interface: I/O Boundary Scan Application Switching Characteristics

| PARAMETER | TEST CONDITIONS | MIN MAX | UNIT |
| :---: | :---: | :---: | :---: |
| $\mathrm{f}_{\text {(clock) }} \quad$ Clock frequency, TCK |  | 10 | MHz |
| $\mathrm{t}_{\mathrm{c}} \quad$ Cycle time, TCK |  | 100 | ns |
| $\mathrm{t}_{\mathrm{w}(\mathrm{L})} \quad$ Pulse duration low, PCLK | 50\% reference points | 40 | ns |
| $\mathrm{t}_{\mathrm{w}(\mathrm{H})} \quad$ Pulse duration high, PCLK | 50\% reference points | 40 | ns |
| $\mathrm{t}_{\text {su }} \quad$ Setup time - TDI, TMS1; Valid before TCK $\uparrow \downarrow$ | 20\% to $80 \%$ reference points | 8 | ns |
| $t_{h} \quad$ Hold time - TDI, TMS1; Valid after TCK $\uparrow \downarrow$ |  | 2 | ns |
| $t_{t} \quad$ Transition time |  | 5 | ns |
| $\mathrm{t}_{\mathrm{pd}}{ }^{(1)} \quad$ Output propagation, Clock to Q | From (Input) TCK $\downarrow$ to (Output) TDO1 | 312 | ns |

(1) Switching characteristics over recommended operating conditions, $\mathrm{C}_{\mathrm{L}}$ (minimum timing) $=5 \mathrm{pF}, \mathrm{C}_{\mathrm{L}}$ (maximum timing) $=85 \mathrm{pF}$ (unless otherwise noted).


Figure 10. Boundary Scan Timing

## 7 Parameter Measurement Information

### 7.1 Power Consumption

Table 5 lists the typical current and power consumption of the individual supplies.
Normal mode refers to operation during full functionality, active product operation. Typical values correspond to power dissipated on nominal process devices operating at nominal voltage and $70^{\circ} \mathrm{C}$ junction temperature (approximately $25^{\circ} \mathrm{C}$ ambient) displaying typical video-graphics content from a high frequency source. Maximum values correspond to power dissipated on fast process devices operating at high voltage and $105^{\circ} \mathrm{C}$ junction temperature (approximately $55^{\circ} \mathrm{C}$ ambient) displaying typical video-graphics content from a high-frequency source. The increased power dissipation observed on fast process devices operated at maximum recommended temperatures is primarily a result of increased leakage current. Maximum power values are estimates and may not reflect the actual final power consumption of the device.

Table 5. Power Consumption

| PARAMETER | TEST <br> CONDITIONS | MIN | NOM | MAX |
| :--- | :--- | ---: | ---: | ---: | UNIT

## 8 Detailed Description

### 8.1 Overview

In DLP-based solutions, image data is $100 \%$ digital from the DLPC350 input port to the image on the DMD. The image stays in digital form and is not converted into an analog signal. The DLPC350 controller processes the digital input image and converts the data into a format needed by the DMD. The DMD steers light by using binary pulse-duration modulation (PWM) for each micromirror. For further details, refer to DMD data sheet (TI literature number DLPS028 for the DLP4500 and DLPS032 for the DLP4500NIR).
Figure 13 is the DLPC350 controller functional block diagram. As part of the pixel processing functions, the DLPC350 controller offers format conversion functions: chroma interpolation and color-space conversion. The DLPC350 controller also offers several image-enhancement functions. The DLPC350 controller also supports the necessary functions to format the input data to the DMD. The pixel processing functions allow the DLPC350 controller and DMD to support a wide variety of resolutions including NTSC, PAL, XGA, and WXGA. The pixel processing functions can be optionally bypassed with the native $912 \times 1140$ pixel resolution to support direct one-to-one pixel mapping.
When accurate pattern display is needed, the native $912 \times 1140$ input resolution pattern has a one-to-one association with the corresponding micromirror on the DMD. The DLPC350 controller enables high-speed display of these patterns. This functionality is well-suited for techniques such as structured light, additive manufacturing, or digital exposure.
Commands can be input to the DLPC350 controller over an $I^{2} \mathrm{C}$ interface.
The DLPC 350 controller takes as input $24-$, 27 -, or 30 -bit RGB data at up to $120-\mathrm{Hz}$ frame rate. This frame rate is composed of three colors (red, green, and blue) with each color equally divided in the $120-\mathrm{Hz}$ frame rate. Thus, each color has a 2.78 -ms time slot allocated. Because each color has an 8-, 9-, or 10-bit depth, each color time slot is further divided into bit-planes. A bit-plane is the 2-dimensional arrangement of one-bit extracted from all the pixels in the full color 2D image to implement dynamic depth (see Figure 11).


Figure 11. Bit Slices
The length of each bit-plane in the time slot is weighted by the corresponding power of two of its binary representation. This provides a binary pulse-duration modulation of the image. For example, a 24 -bit RGB input has three colors with 8 -bit depth each. Each color time slot is divided into eight bit-planes, with the sum of the weight of all bit planes in the time slot equal to 256 . See Figure 12 for an illustration of this partition of the bits in a frame.


Figure 12. Bit Partition in a Frame for an 8-Bit Color

## Overview (continued)

Therefore, a single video frame is composed of a series of bit-planes. Because the DMD mirrors can be either on or off, an image is created by turning on the mirrors corresponding to the bit set in a bit-plane. With binary pulseduration modulation, the intensity level of the color is reproduced by controlling the amount of time the mirror is on. For a 24 -bit RGB frame image input to the DLPC350 controller, the DLPC350 controller creates 24 bitplanes, stores them in a double-buffered eDRAM embedded in the chip, and sends them to the DMD, one bitplane at a time. Depending on the bit weight of the bit-plane, the DLPC350 controller controls the time this bitplane is illuminated, controlling the intensity of the bit-plane. To improve image quality in video frames, these bitplanes, time slots, and color frames are shuffled and interleaved with spatial-temporal algorithms by the DLPC350 controller.

### 8.2 Functional Block Diagram



Figure 13. DLPC350 Functional Block Diagram

## Functional Block Diagram (continued)



Figure 14. Chipset Block Diagram

### 8.3 Feature Description

### 8.3.1 Board Level Test Support

The In-Circuit Three-State Enable signal (ICTSEN) is a board-level test control signal. By driving ICTSEN to a logic high state, all controller outputs (except TDO1) are 3-stated.
The ICTSEN and TRST should be electrically tied together to put DLPC350 pins in tri-state during JTAG boundary scan operation in case other chips exist on the board interfacing with DLPC350.

The DLPC350 controller also provides JTAG boundary scan support on all I/O signals, non-digital I/O, and a few special signals. Exceptions are defined in Table 6.

Table 6. Signals Not Covered by JTAG

| SIGNAL NAME | PKG BALL |
| :---: | :---: |
| USB_DAT_N | E3 |
| USB_DAT_P | E2 |
| HW_TEST_EN | V7 |
| VPGM | D17 |
| EXRES | A3 |
| MOSC | A14 |
| MOSCN | A15 |
| RA_IN_P | AB10 |
| RA_IN_N | AA10 |
| RB_IN_P | Y11 |
| RB_IN_N | W11 |
| RC_IN_P | AB12 |
| RC_IN_N | AA12 |
| RD_IN_P | Y13 |
| RD_IN_N | W13 |
| RE_IN_P | AB14 |
| RE_IN_N | AA14 |
| RCK_IN_P | Y9 |
| RCK_IN_N | W9 |

### 8.4 Device Functional Modes

### 8.4.1 Structured Light Applications

For other applications where this video enhancement is not desired, the video processing algorithms can be bypassed and replaced with a specific set of bit-planes. The bit-depth of the pattern is then allocated into the corresponding time slots. Furthermore, an output trigger signal is also synchronized with these time slots to indicate when the image is displayed. For structured light applications, this mechanism provides the capability to display a set of patterns and signal a camera to capture these patterns overlaid on an object.

The DLPC350 controller stores two 24-bit frames in its internal memory buffer. This 48 1-bit planes display buffer allows the DLPC350 controller to send one 24-bit buffer to the DMD array while the second buffer is filled from flash or streamed in through the 24 -bit RGB interface. In streaming mode, the DMD array displays the previous 24 -bit frame while the current frame fills the second 24 -bit frame of the display buffer. After a 24 -bit frame is displayed, the buffer rotates accessing the next 24 -bit frame to the DMD. Thus, the displayed image is a 24 -bit frame behind the data streamed through the 24-bit RGB parallel interface.
In structured light mode, the 48 1-bit planes can be pre-loaded from flash memory, and then sequenced with a combination of patterns with different bit depths. To synchronize a camera to the displayed patterns, the DLPC350 controller supports three trigger modes: mode 0, mode 1, and mode 2.
In mode 0, the vertical sync is used as trigger input. In mode 1, a TRIG_IN_1 pulse indicates to the DLPC350 controller to advance to the next pattern, while TRIG_IN_2 starts and stops the pattern sequence. In both modes 0 and 1, TRIG_OUT_1 frames the exposure time of the pattern, while TRIG_OUT_2 indicates the start of the pattern sequence or internal buffer boundary of 24-bit planes. In mode 2, the TRIG_IN_1 signal toggles between two consecutive patterns, while a TRIG_IN_2 pulse advances to the next pair of patterns.
In trigger mode 0, shown in Figure 15, the VSYNC starts the pattern sequence display. The pattern sequence consists of a series of three consecutive patterns. The first pattern sequence consists of P1, P2, and P3. Because P3 is an RGB pattern, it is shown with its time sequential representation of P3.1, P3.2, and P3.3. The second pattern sequence consists of three patterns: P4, P5, and P6. The third sequence consists of P7, P8, and P9. TRIG_OUT_1 frames each pattern exposed, while TRIG_OUT_2 indicates the start of each of the three pattern sequences.

An example of trigger mode 1 is shown in Figure 16. Pattern sequences of four are displayed. TRIG_OUT_1 frames each pattern exposed, while TRIG_OUT_2 indicates the start of each four-pattern sequence. TRIG_IN_1 pulses advance the pattern.
Another example for mode 1 is shown in Figure 17, where pattern sequences of three are displayed. TRIG_OUT_1 frames each pattern displayed, while TRIG_OUT_2 indicates the start of each three-pattern sequence. TRIG_IN_2 serves as a start and stop signal. When high, the pattern sequence starts or continues. Note that in the middle of displaying the P4 pattern, TRIG_IN_2 is low, so the sequence stops displaying P4. When TRIG_IN_2 is raised, the pattern sequence continues where it stopped by re-displaying P4.
For trigger mode 2, shown in Figure 18, TRIG-IN_1 alternates between two patterns, while TRIG_IN_2 advances to the next pair of patterns. Table 7 shows the allowed pattern combinations in relation to the bit depth of the pattern.

## Device Functional Modes (continued)



Figure 15. Mode 0 Trigger Timing Diagram


Figure 16. Mode 1 Triggers Timing Diagram for 6-bit Patterns


Figure 17. Mode 1 Trigger Timing Diagram
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## Device Functional Modes (continued)



Figure 18. Mode 2 Trigger Timing Diagram

Table 7. Allowed Pattern Combinations

| BIT DEPTH | EXTERNAL RGB <br> INPUT PATTERN <br> RATE (Hz) | PRE-LOADED <br> PATTERN RATE (Hz) | MAXIMUM NUMBER OF <br> PATTERNS <br> (PRE-LOADED) |
| :---: | :---: | :---: | :---: |
| 1 | 2880 | 4225 | 48 |
| 2 | 1428 | 1428 | 24 |
| 3 | 636 | 636 | 16 |
| 4 | 588 | 588 | 12 |
| 5 | 480 | 500 | 8 |
| 6 | 400 | 400 | 8 |
| 7 | 222 | 222 | 6 |
| 8 | 120 | 120 | 6 |

### 8.4.2 (LVDS) Receiver Supported Pixel Mapping Modes

Table 8. (LVDS) Receiver Supported Pixel Mapping Modes

| LVDS Receiver Input | Mapping Selection 1 | Mapping Selection 2 | Mapping Selection 3 | Mapping Selection 4 (18-bit Mode) |
| :---: | :---: | :---: | :---: | :---: |
| RA Input Channel |  |  |  |  |
| RDA(6) | map to GRN(4) | map to GRN(2) | map to GRN(0) | map to GRN(4) |
| RDA(5) | map to RED(9) | map to RED(7) | map to RED(5) | map to RED(9) |
| RDA(4) | map to RED(8) | map to RED(6) | map to RED(4) | map to RED(8) |
| RDA(3) | map to RED(7) | map to RED(5) | map to RED(3) | map to RED(7) |
| RDA(2) | map to RED(6) | map to RED(4) | map to RED(2) | map to RED(6) |
| RDA(1) | map to RED(5) | map to RED(3) | map to RED(1) | map to RED(5) |
| RDA(0) | map to RED(4) | map to RED(2) | map to RED(0) | map to RED(4) |
| RB Input Channel |  |  |  |  |
| RDB(6) | map to $\operatorname{BLU}(5)$ | map to $\operatorname{BLU}(3)$ | map to BLU(1) | map to BLU(5) |
| RDB(5) | map to BLU(4) | map to BLU(2) | map to BLU(0) | map to BLU(4) |
| RDB(4) | map to GRN(9) | map to GRN(7) | map to GRN(5) | map to GRN(9) |
| RDB(3) | map to GRN(8) | map to GRN(6) | map to GRN(4) | map to GRN(8) |
| RDB(2) | map to GRN(7) | map to GRN(5) | map to GRN(3) | map to GRN(7) |
| RDB(1) | map to GRN(6) | map to GRN(4) | map to GRN(2) | map to GRN(6) |
| RDB(0) | map to GRN(5) | map to GRN(3) | map to GRN(1) | map to GRN(5) |
| RC Input Channel |  |  |  |  |
| RDC(6) | map to DEN |  |  |  |
| RDC(5) | map to VSYNC |  |  |  |
| RDC(4) | map to HSYNC |  |  |  |
| RDC(3) | map to $\operatorname{BLU}(9)$ | map to $\operatorname{BLU}(7)$ | map to $\operatorname{BLU}(5)$ | map to BLU(9) |
| RDC(2) | map to $\operatorname{BLU}(8)$ | map to $\operatorname{BLU}(6)$ | map to BLU(4) | map to BLU(8) |
| RDC(1) | map to BLU(7) | map to BLU(5) | map to $\operatorname{BLU}(3)$ | map to BLU(7) |
| RDC(0) | map to BLU(6) | map to BLU(4) | map to BLU(2) | map to BLU(6) |
| RD Input Channel |  |  |  |  |
| RDD(6) | map to Field (option 1 if available) |  |  |  |
| RDD(5) | map to BLU(3) | map to BLU(9) | map to BLU(7) | NO MAPPING |
| RDD(4) | map to BLU(2) | map to BLU(8) | map to BLU(6) | NO MAPPING |
| RDD(3) | map to GRN(3) | map to GRN(9) | map to GRN(7) | NO MAPPING |
| RDD(2) | map to GRN(2) | map to GRN(8) | map to GRN(6) | NO MAPPING |
| RDD(1) | map to RED(3) | map to RED(9) | map to RED(7) | NO MAPPING |
| RDD(0) | map to RED(2) | map to RED(8) | map to RED(6) | NO MAPPING |
| RE Input Channel |  |  |  |  |
| RDE(6) | map to Field (option 2 if available) |  |  |  |
| RDE(5) | map to $\operatorname{BLU}(1)$ |  | map to BLU(9) | NO MAPPING |
| RDE(4) | map to BLU(0) |  | map to BLU(8) | NO MAPPING |
| RDE(3) | map to GRN(1) |  | map to GRN(9) | NO MAPPING |
| RDE(2) | map to GRN(0) |  | map to GRN(8) | NO MAPPING |
| RDE(1) | map to RED(1) |  | map to RED(9) | NO MAPPING |
| RDE(0) | map to RED(0) |  | map to RED(8) | NO MAPPING |

Mapping options are selected via software. If only 18 -bit mode is used (mapping selection number 4 in Table 8), and if a Field 1 or Field 2 input is not needed, then the LVDS RD Input Channel (RDD) and RE Input Channel (RDE) may be omitted in the board layout.

## 9 Application and Implementation

## NOTE

Information in the following applications sections is not part of the Tl component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

The DLP4500 family of DMDs must be coupled with the DLPC350 controller to provide a reliable solution for many different structured light and video applications. The DMDs are spatial light modulators which reflect incoming light from an illumination source to one of two directions, with the primary direction being into a projection or collection optic. Each application is derived primarily from the optical architecture of the system and the format of the data coming into the DLPC350. Applications of interest include 3D measurement systems, spectrometers, medical systems, and compressive sensing.

### 9.2 Typical Applications

### 9.2.1 Typical Chipset Application

Figure 19 shows a typical embedded system application using the DLPC350 controller and DMD. In this configuration, the DLPC350 controller supports a 24-bit parallel RGB input, typical of LCD interfaces, from an external source or processor. This system supports both still and motion video sources. However, the controller only supports sources with periodic synchronization pulses. This is ideal for motion video sources, but can also be used for still images by maintaining periodic syncs and only sending a new frame of data when needed. The still image must be fully contained within a single video frame and meet the frame timing constraints. The DLPC350 controller refreshes the displayed image at the source frame rate and repeats the last active frame for intervals in which no new frame has been received.


Figure 19. Typical Application Schematic

## Typical Applications (continued)

### 9.2.1.1 Design Requirements

All applications using the DLP4500 and DLP4500NIR chipset require both the controller and DMD components for operation. The system also requires an external parallel flash memory device loaded with the DLPC350 configuration and support firmware. The chipset has several system interfaces and requires some support circuitry. The following interfaces and support circuitry are required:

- DLPC350 system interfaces:
- Control interface
- Trigger interface
- Input data interface
- Illumination interface
- DLPC350 support circuitry and interfaces:
- Reference clock
- PLL
- Program memory flash interface
- DMD interfaces:
- DLPC350 to DMD digital data
- DLPC350 to DMD control interface
- DLPC350 to DMD micromirror reset control interface


### 9.2.1.2 Detailed Design Procedure

### 9.2.1.2.1 DLPC350 System Interfaces

The DLPC350 supports a 30-bit parallel RGB interface for image data transfers from another device and a 30-bit interface for video data transfers. The system input requires proper generation of the PWRGOOD and POSENSE inputs to ensure reliable operation. The two primary output interfaces are the illumination driver control interface and sync outputs.

### 9.2.1.2.1.1 Control Interface

The DLPC350 supports $I^{2} \mathrm{C}$ or USB commands through the control interface. The control interface allows another master processor to send commands to the DLPC350 to query system status or perform realtime operations such as LED driver current settings.
The DLPC350 controller offers two different sets of slave addresses. The I2C_ADDR_SEL pin provides the ability to select an alternate set of 7 -bit I ${ }^{2} \mathrm{C}$ slave address only during power-up. If I2C_ADDR_SEL is low, then the DLPC350 slave addresses are $0 \times 34$ and $0 \times 35$. If I2C-ADDR_SEL is high, then the DLPC350 slave address is $0 \times 3 \mathrm{~A}$ and 0x3B. This signal also changes the serial number for the USB device so that two DLPC350s can be connected to one computer through USB. Once the system initialization is complete, this pin will be available as a GPIO. See the DLPC350 Programmer's Guide (TI literature number DLPU010) for detailed information about these operations.
Table 9 lists a description for active signals used by the DLPC350 to support the $\mathrm{I}^{2} \mathrm{C}$ interface.
Table 9. Active Signals - $I^{2} C$ Interface

| Signal Name | Description |
| :--- | :--- |
| I2C1_SCL | $I^{2} \mathrm{C}$ clock. Bidirectional open-drain signal. $I^{2} \mathrm{C}$ slave clock input from the external <br> processor. |
| I2C1_SDA | $I^{2} \mathrm{C}$ data. Bidirectional open-drain signal. $I^{2} \mathrm{C}$ slave to accept command or transfer data <br> to and from the external processor. |
| I2C0_SCL | I $^{2} \mathrm{C}$ bus 0, clock; $I^{2} \mathrm{C}$ master for on-board peripherals |
| I2C0_SDA | $I^{2} \mathrm{C}$ bus 0, data; $I^{2} \mathrm{C}$ master for on-board peripherals |

## DLPC350

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### 9.2.1.2.1.2 Input Data Interface

The data interface has two components: a parallel RGB-input port and an FPD-Link LVDS input port. Both components can support up to 30 bits and have a nominal I/O voltage of 3.3 V . The Interface Timing Requirements in Specifications list the maximum and minimum input timing specifications for both components.
The parallel RGB port can support up to 30 bits in video mode. In pattern mode, the upper 8 -bits of each color convert the 30 -bit input into a 24 -bit RGB input.

The FPD-Link input port can be configured to connect to a video decoder device or an external processor through a 24-, 27-, or 30-bit interface.
Table 10 provides a description of the signals associated with the data interface.
Table 10. Active Signals - Data Interface

| Signal Name | Description |
| :--- | :--- |
| RGB Parallel Interface |  |
| P1_(A, B, C)_[0:9] | lo-bit data inputs 10 bits for each of the red, green, and blue channels). If <br> interfacing to a system with less than 10-bits per color, connect the bus of the <br> red, green, and blue channels to the upper bits of the DLPC 350 10-bit bus. |
| P1A_CLK | Pixel clock; all input signals on data interface are synchronized with this clock. |
| P1_VSYNC | Vertical sync |
| P1_HSYNC | Horizontal sync |
| P1_DATAEN | Input data valid |
| FPD-Link LVDS Input |  |
| RCK | Differential input signal for clock |
| RA_IN | Differential input signal for data channel A |
| RB_IN | Differential input signal for data channel B |
| RC_IN | Differential input signal for data channel C |
| RD_IN | Differential input signal for data channel D |
| RE_IN | Differential input signal for data channel E |

The A, B, and C input data channels of Port 1 can be internally swapped for optimum board layout.

### 9.2.1.2.2 DLPC350 System Output Interfaces

### 9.2.1.2.2.1 Illumination Interface

An illumination interface is provided that supports up to a 3-channel LED driver.
The illumination interface provides signals that support LED driver enable, LED enable, LED enable select, and PWM signals to control the LED current. Table 11 describes the active signals for the illumination interface.

Table 11. Active Signals - Illumination Interface

| Signal Name | Description |
| :--- | :--- |
| HEARTBEAT | LED blinks continuously to indicate system is running fine |
| FAULT_STATUS | LED off indicates system fault |
| LEDR_EN | Red LED enable |
| LEDG_EN | Green LED enable |
| LEDB_EN | Blue LED enable |
| LEDR_PWM | Red LED PWM signal used to control the LED current |
| LEDG_PWM | Green LED PWM signal used to control the LED current |
| LEDB_PWM | Blue LED PWM signal used to control the LED current |

### 9.2.1.2.2.2 Trigger Interface (Sync Outputs)

The DLPC350 controller outputs a trigger signal for synchronizing displayed patterns with a camera, sensor, or other peripherals.

The signals that support sync-output are horizontal sync, vertical sync, two input triggers, and two output triggers. Depending on the application, these signals control how the pattern is displayed.

Table 12. Active Signals - Trigger and Sync Interface

| Signal Name | Description |
| :--- | :--- |
| P1_HSYNC | Horizontal sync |
| P1_VSYNC | Vertical sync |
| TRIG_IN_1 | Advances the pattern display or displays two alternating patterns, depending on the <br> mode |
| TRIG_IN_2 | Pauses the pattern display or advances the pattern by two, depending on the mode |
| TRIG_OUT_1 | Active high during pattern exposure |
| TRIG_OUT_2 | Active high to indicate first pattern display |

### 9.2.1.2.3 DLPC350 System Support Interfaces

### 9.2.1.2.3.1 Reference Clock

The DLPC350 controller requires a $32-\mathrm{MHz} 3.3-\mathrm{V}$ external input from an oscillator. This signal serves as the DLPC350 reference clock from which the majority of the interfaces derive their timing. This includes DMD interfaces and serial interfaces.

### 9.2.1.2.3.2 PLL

The DLPC350 controller contains two PLLs (PLLM and PLLD), each of which have dedicated 1.2-V digital and $1.8-\mathrm{V}$ analog supplies. These $1.2-\mathrm{V}$ PLL pins should be individually isolated from the main $1.2-\mathrm{V}$ system supply via a ferrite bead. The impedance of the ferrite bead should be much greater than the capacitor at frequencies where noise is expected. The impedance of the ferrite bead must also be less than $0.5 \Omega$ in the frequency range of 100 to 300 kHz and greater than $10 \Omega$ at frequencies greater than 100 MHz .

As a minimum, the 1.8-V analog PLL power and ground pins should be isolated using an LC filter with a ferrite bead serving as the inductor and a $0.1-\mu \mathrm{F}$ capacitor on the DLPC350 side of the ferrite bead. TI recommends that this $1.8-\mathrm{V}$ PLL power be supplied from a dedicated linear regulator and each PLL should be individually isolated from the regulator. The same ferrite recommendations described for the $1.8-\mathrm{V}$ analog PLL supply apply to the $1.2-\mathrm{V}$ digital PLL supply.

When designing the overall supply filter network, care must be taken to ensure that no resonances occur. Take special care when using the $1-$ to $2-\mathrm{MHz}$ band because this coincides with the PLL natural loop frequency.

### 9.2.1.2.3.3 Program Memory Flash Interface

The DLPC350 controller provides two external program memory chip selects:

- $\overline{\text { PM_CS_1 }}$ is mandatory CS for boot flash device (Standard NOR Flash $\leq 128 \mathrm{Mb}$ ).
- $\overline{\text { PM_CS_2 }}$ is available for an optional flash device ( $\leq 128 \mathrm{Mb}$ ).

The flash access timing is fixed at 100.5 ns for read timing, and 154.1 ns for write timing. In standby mode, these values change to 803.5 ns for read timing and 1232.1 ns for write timing.

These timing values assume a maximum single direction trace length of 75 mm . When an additional flash is used in conjunction with the boot flash, stub lengths must be kept short and located as close as possible to the flash end of the route.

The DLPC350 controller provides enough program memory address pins to support a flash device up to 128 Mb . PM_ADDR_22 and PM_ADDR_21 are GPIO pins on reset, so they require board-level pulldown resistors to prevent the flash address bits from floating during initial bootload.
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### 9.2.1.2.4 DMD Interfaces

### 9.2.1.2.4.1 DLPC350 to DMD Digital Data

The DLPC350 controller provides the pattern data to the DMD over a double data rate (DDR) interface.
Table 13 describes the signals used for this interface.
Table 13. Active Signals - DLPC350 to DMD Digital Data Interface

| DLPC350 Signal Name | DMD Signal Name |
| :---: | :---: |
| DMD_D(23:0) | DATA(23:0) |
| DMD_DCLK | DCLK |

### 9.2.1.2.4.2 DLPC350 to DMD Control Interface

The DLPC350 controller provides the control data to the DMD over a serial bus.
Table 14 describes the signals used for this interface.
Table 14. Active Signals - DLPC350 to DMD Control Interface

| DLPC350 <br> Signal Name | DMD <br> Signal Name | Description |
| :---: | :---: | :--- |
| DMD_SAC_BUS | SAC_BUS | DMD stepped-address control (SAC) bus data |
| DMD_SAC_CLK | SAC_CLK | DMD stepped-address control (SAC) bus clock |
| $\overline{\text { DMD_LOADB }}$ | $\overline{\text { LOADB }}$ | DMD data load signal |
| DMD_SCTRL | SCTRL | DMD data serial control signal |
| DMD_TRC | TRC | DMD data toggle rate control |

### 9.2.1.2.4.3 DLPC350 to DMD Micromirror Reset Control Interface

The DLPC350 controls the micromirror clock pulses in a manner to ensure proper and reliable operation of the DMD.

Table 15 describes the signals used for this interface.
Table 15. Active Signals - DLPC350 to DMD Micromirror Reset Control Interface

| DLPC350 Signal Name | DMD <br> Signal Name | Description |
| :---: | :---: | :--- |
| DMD_DRC_BUS | DRC_BUS | DMD reset control serial bus |
| $\overline{\text { DMD_DRC_OE }}$ | $\overline{\text { DRC_OE }}$ | DMD reset control output enable |
| DMD_DRC_STRB | DRC_STRB | DMD reset control strobe |

## 10 Power Supply Recommendations

### 10.1 System Power and Reset

There are several factors related to system power and reset, which affect the DC error (offset) and AC noise at the DLPC350 power pins.

### 10.1.1 Default Conditions

At system power-up, the DLPC350 controller performs a power-up initialization routine that defaults the controller to its normal power mode, enables related clocks at their full rate, and releases associated resets. Most other clocks default to disabled with associated resets asserted until released by the processor. These same defaults are also applied as part of all system reset events that occur without removing or recycling power.
Following power-up or system reset initialization, the system boots from an external flash memory after which it enables the rest of the controller clocks. After system initialization is complete, application software determines if and when to enter standby mode.

### 10.1.1.1 1.2-V System Power

The controller supports a low-cost power delivery system with a single 1.2-V power source derived from a switching regulator. The main core should receive 1.2-V power directly from the regulator output, and the internal DLPC350 PLLs (VDD_12_PLLM, VDD_12_PLLD) should receive individually filtered versions of this $1.2-\mathrm{V}$ power. For specific filter recommendations, see Recommended DLPC350 PLL Layout Configuration.

### 10.1.1.2 1.8-V System Power

A single 1.8-V power source should be used to supply both internal PLLs (VDD_18_PLLM, VDD_18_PLLD). To keep the power as clean as possible, TI recommends that this power be sourced via a linear regulator that is individually filtered for each PLL. For specific filter recommendations, see Recommended DLPC350 PLL Layout Configuration.

### 10.1.1.3 1.9-V System Power

To maximize signal integrity, TI recommends that an independent linear regulator be used to source the 1.9-V supply that supports the DMD interface (VDD_DMD). To achieve maximum performance, this supply must be tightly regulated to operating within a $1.9 \mathrm{~V} \pm 0.1 \mathrm{~V}$ range.

### 10.1.1.4 3.3-V System Power

The DLPC350 controller supports a low-cost power delivery system with a single 3.3-V power source derived from a switching regulator. This 3.3-V power supplies all LVCMOS I/O. 3.3-V power (VDD33) should remain active in all power modes for which the $1.2-\mathrm{V}$ core power is applied.

### 10.1.1.5 FPD-Link Input LVDS System Power

The controller supports an FPD-Link compatible LVDS input for an additional method of inputting video or graphics data for display. This interface has some special controller power considerations that are separate from the other controller 1.2- or 3.3-V power rails. An FPD-Link 1.2-V power pin configuration example is shown in Figure 20.

## System Power and Reset (continued)



Figure 20. FPD-Link 1.2-V Power Pin Configuration

In addition, TI recommends to place the $0.1-\mu \mathrm{F}$ low equivalent series resistance (ESR) capacitors to ground as close to the FPD-Link power pins of the DLPC350 controller as possible. FPD-Link 3.3-V power pins should also use external capacitors in the same manner as the 1.2-V pins. When FPD-Link is not utilized, the filtering can be omitted. However, the corresponding voltages must still be provided in order to avoid potential long-term reliability issues.


Figure 21. Initialization Timeline

### 10.1.2 System Power-up and Power-down Sequence

Although the DLPC350 controller requires an array of power supply voltages, (for example, VDDC, VDD_1X_PLLX, VCC_18, VCC_DMD, and VCCXX_FPD), there are no restrictions regarding the relative order of power supply sequencing to avoid damaging the DLPC350 controller. This is true for both power-up and powerdown. Similarly, there is no minimum time between powering-up or powering-down the different supplies of the DLPC350 controller. Note that it is not uncommon for there to be power-sequencing requirements for other devices that share power supplies with the DLPC350 controller.
Although there is no risk of damaging the DLPC350 controller as a result of a given power sequence, from a functional standpoint there are a few specific power-sequencing recommendations to ensure proper operation.

- 1.2-V core power should be applied whenever any I/O power is applied. This ensures that the powered I/O pins are set to a known state. Thus, TI recommends that core power be applied first. Other supplies should be applied only after the 1.2-V DLPC350 core has ramped up.
- All controller power should be applied before POSENSE is asserted to ensure proper power-up initialization is


## System Power and Reset (continued)

performed. 1.8-V PLL power, 1.9-V I/O power, and 3.3-V I/O power should remain applied as long as 1.2-V core power is applied and POSENSE is asserted.
It is assumed that all DLPC350 power-up sequencing is handled by external hardware. It is also assumed that an external power monitor will hold the DLPC350 controller in system reset during power-up (that is, POSENSE $=$ 0). It should continue to assert system reset until all DLPC350 voltages have reached minimum specified voltage levels. During this time, all controller I/O are either 3-stated or driven low. The master PLL (PLLM) is released from reset upon the low-to-high transition of POSENSE, but the DLPC350 controller keeps the rest of the controller in reset for an additional 100 ms to allow the PLL to lock and stabilize its outputs. After this $100-\mathrm{ms}$ delay, internal resets are de-asserted causing the microprocessor to begin its boot-up routine.

Power Up


PWRGOOD has no impact on operation for 60 ms after rising edge of POSENSE.


Figure 22. Power-up and Power-down Timing

### 10.1.3 Power-On Sense (POSENSE) Support

It is difficult to set up a power monitor to trip exactly on the DLPC350 controller minimum supply voltages specifications. Thus, TI recommends that the external power monitor generating POSENSE target its threshold to $90 \%$ of the minimum supply voltages and ensure that POSENSE remain low for a sufficient amount of time to allow all supply voltages to reach minimum controller requirements and stabilize. Note that the trip voltage for detecting the loss of power is not critical for POSENSE and thus may be as low as $50 \%$ of rated supply voltages. In addition, the reaction time to respond to a low voltage condition is not critical for POSENSE. INIT_DONE has much more critical requirements in these areas.

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## System Power and Reset (continued)

### 10.1.4 Power-Good (PWRGOOD) Support

The PWRGOOD signal is defined to be an early warning signal that should alert the controller $500 \mu$ s before DC supply voltages have dropped below specifications. This allows the controller time to park the DMD, ensuring the integrity of future operation. TI recommends that monitor sensing PWRGOOD be on the input side of the supply regulators.

### 10.1.5 5-V Tolerant Support

With the exception of USB_DAT, the DLPC350 controller does not support any other 5-V tolerant I/O.

### 10.1.6 Power Reset Operation

Immediately following a power-up event, the DLPC350 hardware automatically brings up the master PLL and places the controller in NORMAL power mode. It then follows the standard system reset procedure (see System Reset Operation).

### 10.1.7 System Reset Operation

Immediately following any type of system reset (power-up reset, PWRGOOD reset, and so forth), the DLPC350 controller automatically returns to NORMAL power mode and returns to the following state:

- All GPIO 3-state and as a result all GPIO-controlled voltage switches default to enabling power to all the DLPC350 supply lines (assuming that these outputs are externally pulled-high).
- The master PLL remains active (it is only reset on a power-up reset) and most of the derived clocks are active. However, only those resets associated with the internal processor and its peripherals are released.
- The internal processor associated clocks default to their full clock rates, as boot-up occurs at full speed.
- The PLL feeding the DDR DMD interface (PLLD) defaults to its power-down mode, and all derived clocks are inactive with the corresponding resets asserted.
- The DMD interface (except $\overline{\text { DMD_DRC_OE }}$ ) default outputs to a logic low state. $\overline{\mathrm{DMD}} \mathbf{D R C \_ O E}$ defaults to 3state, but should be pulled high via an external $30-$ to $51-\mathrm{k} \Omega$ pullup resistor on the $\mathrm{PC} \bar{B}$.
- All resets output by the DLPC350 controller remain asserted until released by the internal processor (after boot-up).
- The DLPC350 controller boots-up from external flash. After the DLPC350 controller boots, it:
- Configures the programmable DDR clock generator (DCG) clock rates (that is, the DMD LPDDR interface rate).
- Enables the DCG PLL (PLLD) while holding the divider logic in reset.
- After the DCG PLL locks, the firmware sets the DMD clock rates.
- The DLPC350 firmware then releases the DCG divider logic resets, which in turn, enables all derived DCG clocks.
- After the clocks are configured, an internal memory test is performed. See Figure 23 and note that GPIO26 is the INIT_DONE signal.
Application software should wait for a wake-up command from the user. After the controller is requested to wakeup, the software should place the controller back in NORMAL mode and re-initialize clocks and resets as required. See reset timing requirements in Reset Timing Requirements.


## System Power and Reset (continued)



Figure 23. Internal Memory Test Diagram

## 11 Layout

### 11.1 Layout Guidelines

### 11.1.1 DMD Interface Design Considerations

The DMD interface is modeled after the low-power DDR-memory (LPDDR) interface. To minimize power dissipation, the LPDDR interface is defined to be unterminated. As a result, PCB signal-integrity management is imperative. Impedance control and crosstalk mitigation is critical to robust operation. LPDDR board design recommendations include trace spacing that is three times the trace width, impedance control within 10\%, and signal routing directly over a neighboring reference plane (ground or $1.9-\mathrm{V}$ plane).
DMD interface performance is also a function of trace length; therefore the length of the trace limits performance. The DLPC350 controller only works over a narrow range of DMD signal routing lengths at 120 MHz . Ensuring positive timing margins requires attention to many factors.
As an example, the DMD interface system timing margin can be calculated as follows.
Setup Margin $=($ DLPC350 Output Setup $)-($ DMD Input Setup $)-($ PCB Routing Mismatch $)-($ PCB SI Degradation $)$
Hold-Time Margin = (DLPC350 Output Hold) $-($ (DMD Input Hold $)-($ PCB Routing Mismatch $)-($ PCB SI Degradation $)(2)$
PCB signal integrity degradation can be minimized by reducing the affects of simultaneously switching output (SSO) noise, crosstalk, and inter-symbol interface (ISI). Additionally, PCB routing mismatch can be budgeted via controlled PCB routing.
In an attempt to minimize the need for signal integrity analysis that would otherwise be required, the following PCB design guidelines are provided. They describe an interconnect system that satisfies both waveform quality and timing requirements (accounting for both PCB routing mismatch and PCB SI degradation). Variation from these recommendations may also work, but should be confirmed with PCB signal integrity analysis or lab measurements.

### 11.1.2 DMD Termination Requirements

Table 16 lists the termination requirements for the DMD interface. These series resistors should be placed as close to the DLPC350 pins as possible while following all PCB guidelines.

Table 16. Termination Requirements for DMD Interface

| SIGNALS | SYSTEM TERMINATION |
| :--- | :--- |
| DMD_D(23:0), DMD_TRC, DMD_SCTRL, | External $5-\Omega$ series termination at the transmitter |
| DMD_LOADB, DMD_DRC_STRB, |  |
| DMD_DRC_BUS, DMD_SAC_CLK, and |  |
| DMD_SAC_BUS | External $5-\Omega$ series termination at the transmitter |
| DMD_DCLK | External $0-\Omega$ series termination. This signal must be <br> externally pulled-up to VDD_DMD via a $30-k \Omega$ <br> $51-k \Omega \Omega$ <br> resistor |
|  |  |
| DMD_DRC_OE |  |

DMD_CLK and DMD_SAC_CLK clocks should be equal lengths, as shown in Figure 24.


Figure 24. Series-Terminated Clocks

### 11.1.3 Decoupling Capacitors

The decoupling capacitors should be given placement priority. The supply voltage pin of the capacitor should be located close to the DLPC350 supply voltage pin or pins. Decoupling capacitors should have two vias connecting the capacitor to ground and two vias connecting the capacitor to the power plane, but if the trace length is less than 0.05 inches, the device can be connected directly to the decoupling capacitor. The vias should be located on opposite sides of the long side of the capacitor, and those connections should be less than 0.05 inches as well.

### 11.1.4 Power Plane Recommendations

For best performance, TI recommends the following:

- Two power planes
- One solid plane for ground (GND)
- One split plane for other voltages with no signal routing on the power planes
- Power and ground pins should be connected to these planes through a via for each pin.
- All device pin and via connections to these planes should use a thermal relief with a minimum of four spokes.
- Trace lengths for the component power and ground pins should be minimized to 0.03 inches or less.
- Vias should be spaced out to avoid forming slots on the power planes.
- High speed signals should not cross over a slot in the adjacent power planes.
- Vias connecting all the digital layers should be placed around the edge of the rigid PCB regions 0.03 inches from the board edges with 0.1 inch spacing prior to routing.
- Placing extra vias is not required if there are sufficient ground vias due to normal ground connections of devices.
- All signal routing and signal vias should be inside the perimeter ring of ground vias.


### 11.1.5 Signal Layer Recommendations

The PCB signal layers should follow typical good practice guidelines including:

- Layer changes should be minimized for single-ended signals.
- Individual differential pairs can be routed on different layers, but the signals of a given pair should not change layers.
- Stubs should be avoided.
- Only voltage or low-frequency signals should be routed on the outer layers, except as noted previously in this document.
- Double data rate signals should be routed first for best impedance and trace length matching.

The PCB should have a solder mask on the top and bottom layers. The mask should not cover the vias.

- Except for fine pitch devices (pitch $\leq 0.032$ inches), the copper pads and the solder mask cutout should be of the same size.
- Solder mask between pads of fine pitch devices should be removed.
- In the BGA package, the copper pads and the solder mask cutout should be of the same size.


### 11.1.6 General Handling Guidelines for CMOS-Type Pins

To avoid potentially damaging current caused by floating CMOS input-only pins, TI recommends that unused input pins be tied through a pullup resistor to its associated power supply, or a pulldown to ground. For inputs with internal pullup or pulldown resistors, adding an external pullup or pulldown resistor is unnecessary unless specified in the Pin Configuration and Functions section. Note that internal pullup and pulldown resistors are weak and should not be expected to drive an external line.

After power-up or device reset, bidirectional pins are configured as inputs as a reset default until directed otherwise.

Unused output-only pins can be left open.

### 11.1.7 PCB Manufacturing

The DLPC350 Controller and DMD are a high-performance (high-frequency and high-bandwidth) set of components. This section provides PCB guidelines to help ensure proper operation of these components.

The DLPC350 controller board will be a multi-layer PCB with surface mount components on both sides. The majority of large surface mount components are placed on the top side of the PCB. Circuitry is high speed digital logic. The high speed interfaces include:

- $120-\mathrm{MHz}$ DDR interface from DLPC350 to DMD
- $150-\mathrm{MHz}$ LVTTL interface from a video decoder to the DLPC350
- 150-MHz pixel clock supporting 30-bit parallel RGB interface
- LVTTL parallel memory interface between the DLPC350 controller and flash with 70-ns access time
- LVDS flat panel display port to DLPC350

The PCB should be designed to IPC2221 and IPC2222, Class 2, Type Z, at level B producibility and built to IPC6011 and IPC6012, Class 2.

### 11.1.7.1 General Guidelines

Table 17. PCB General Recommendations

| DESCRIPTION | RECOMMENDATION |
| :---: | :---: |
| Configuration | Asymmetric dual stripline |
| Etch thickness (T) | 1.0 -oz. (1.2-mil thick) copper |
| Single-ended signal impedance | $50 \Omega( \pm 10 \%)$ |
| Differential signal impedance | $100 \Omega$ differential $( \pm 10 \%)$ |

### 11.1.7.2 Trace Widths and Minimum Spacings

For best performance, TI recommends the trace widths and minimum spacings shown in Table 18.
Table 18. Trace Widths and Minimum Spacings

| SIGNAL NAME | TRACE WIDTH (inches) | MINIMUM TRACE SPACING <br> (inches) |
| :---: | :---: | :---: |
| P1P2, P1P2V_PLLM, P1P2V_PLLD, <br> P2P5V, P3P3V, P1P9V, A1P8V, <br> A1P8V_PLLD, A1P8V_PLLM | 0.02 | 0.010 |
| VRST, VBIAS, VOFFSET | 0.02 | 0.010 |
| VSS (GND) | 0.02 | 0.005 |
| FANx_OUT | 0.02 | 0.020 |
| DMD_DCLK |  | 0.030 |
| P1A_CLK, P1B_CLK, P1C_CLK |  | 0.030 |

Table 18. Trace Widths and Minimum Spacings (continued)

| SIGNAL NAME | TRACE WIDTH (inches) | MINIMUM TRACE SPACING <br> (inches) |
| :---: | :---: | :---: |
| MOSC, MOSCN |  | 0.030 |

### 11.1.7.3 Routing Constraints

In order to meet the specifications listed in the following tables, typically the PCB designer must route these signals manually (not using automated PCB routing software). In case of length matching requirements, routing traces in a serpentine fashion may be required. Keep the number of turns to a minimum and the turn angles no sharper than $45^{\circ}$. Traces must be 0.1 inches from board edges when possible; otherwise they must be 0.05 inches minimum from the board edges. Avoid routing long traces all around the PCB. PCB layout assumes adjacent trace spacing is twice the trace width. However, three times the trace width will reduce crosstalk and significantly help performance.
The maximum and minimum signal routing trace lengths include escape routing.
Table 19. Signal Length Routing Constraints for DMD Interface

| SIGNALS | MINIMUM SIGNAL <br> ROUTING LENGTH |
| :--- | :---: | :---: |
|  |  | | MAXIMUM SIGNAL |
| :---: |
| ROUTING LENGTH |

(1) Signal lengths below the stated minimum will likely result in overshoot or undershoot.
(2) DMD-DDR maximum signal length is a function of the DMD_DCLK rate.

Each high-speed, single-ended signal should be routed in relation to its reference signal, such that a constant impedance is maintained throughout the routed trace. Avoid sharp turns and layer switching while keeping total trace lengths to a minimum. The following signals should follow the signal matching requirements described in Table 20.

Table 20. High-Speed Signal Matching Requirements for DMD Interface

| SIGNALS | REFERENCE SIGNAL | MAX MISMATCH | UNIT |
| :---: | :---: | :---: | :---: |
| $\frac{\mathrm{DMD} \text { _D }(23: 0), \mathrm{DMD} \text { _TRC, } \mathrm{DMD} \text { _SCTRL, }}{\mathrm{DMD} \text { LOADB }}$ | DMD_DCLK | $\begin{gathered} \pm 200 \\ ( \pm 5.08) \end{gathered}$ | $\begin{gathered} \mathrm{mil} \\ (\mathrm{~mm}) \end{gathered}$ |
| DMD_DRC_STRB, DMD_DRC_BUS, DMD_SAC_BUS, DMD_OE | DMD_SAC_CLK | $\begin{gathered} \pm 200 \\ ( \pm 5.08) \end{gathered}$ | $\begin{gathered} \mathrm{mil} \\ (\mathrm{~mm}) \end{gathered}$ |

The values in Table 20 apply to the PCB routing only. They do not include any internal package routing mismatch associated with the DLPC350 or DMD. Additional margin can be attained if internal DLPC350 package skew is taken into account. Additionally, to minimize EMI radiation, serpentine routes added to facilitate trace length matching should only be implemented on signal layers between reference planes.
Both the DLPC350 output timing parameters and the DMD input timing parameters include a timing budget to account for their respective internal package routing skew. Thus, additional system margin can be attained by comprehending the package variations and compensating for them in the PCB layout. To increase the system timing margin, TI recommends that the DLPC350 package variation be compensated for (by signal group), but it may not be desirable to compensate for DMD package skew. This is due to the fact that each DMD has a different skew profile, making the PCB layout DMD specific. To use a common PCB design for different DMDs, TI recommends that either the DMD package skew variation not be compensated for on the PCB, or the package lengths for all applicable DMDs being considered. Table 21 provides the DLPC350 package output delay at the package ball for each DMD interface signal.

The total length of all the traces in Table 21 should be matched to the DMD_DCLK trace length. Total trace length includes package skews, PCB length, and DMD flex cable length.

Table 21. DLPC350 Package Skew and Routing Trace Length for the DMD Interface

| SIGNAL | TOTAL DELAY (Package Skews) |  | PACKAGE PIN |
| :---: | :---: | :---: | :---: |
|  | (ps) | (mm) |  |
| DMD_D0 | 25.9 | 152.35 | A8 |
| DMD_D1 | 19.6 | 115.29 | B8 |
| DMD_D2 | 13.4 | 78.82 | C8 |
| DMD_D3 | 7.4 | 43.53 | D8 |
| DMD_D4 | 18.1 | 106.47 | B11 |
| DMD_D5 | 11.1 | 65.29 | C11 |
| DMD_D6 | 4.4 | 25.88 | D11 |
| DMD_D7 | 0.0 | 0.00 | E11 |
| DMD_D8 | 14.8 | 87.06 | C7 |
| DMD_D9 | 18.4 | 108.24 | B10 |
| DMD_D10 | 6.4 | 37.65 | E7 |
| DMD_D11 | 4.8 | 28.24 | D10 |
| DMD_D12 | 29.8 | 175.29 | A6 |
| DMD_D13 | 25.7 | 151.18 | A12 |
| DMD_D14 | 19.0 | 111.76 | B12 |
| DMD_D15 | 11.7 | 68.82 | C12 |
| DMD_D16 | 4.7 | 27.65 | D12 |
| DMD_D17 | 21.5 | 126.47 | B7 |
| DMD_D18 | 24.8 | 145.88 | A10 |
| DMD_D19 | 8.3 | 48.82 | D7 |
| DMD_D20 | 23.9 | 140.59 | B6 |
| DMD_D21 | 1.6 | 9.41 | E9 |
| DMD_D22 | 10.7 | 62.94 | C10 |
| DMD_D23 | 16.7 | 98.24 | C6 |
| DMD_DCLK | 24.8 | 145.88 | A9 |
| $\overline{\text { DMD_LOADB }}$ | 18.0 | 105.88 | B9 |
| DMD_SCTRL | 11.4 | 67.06 | C9 |
| DMD_TRC | 4.6 | 27.06 | D9 |

Table 22. Routing Priority

| SIGNAL | ROUTING <br> PRIORITY | ROUTING <br> LAYER | MATCHING <br> REFERENCE SIGNAL | TOLERANCE |
| :--- | :---: | :---: | :---: | :---: |
| DMD_DCLK ${ }^{(1)(2)(3)}$ | 1 | 3 | - | - |
| DMD_D[23:0], DMD_SCTRL(1)(2) (3) (4) | 1 | 3,4 | DMD_DCLK | $\pm 150 \mathrm{mils}$ |
| P1_A[9:0], P1_B[9:0], P1_C[9:0], <br> P1_HSYNC, P1_VSYNC, P1_DATAEN, <br> P1X_CLK | 1 | 3,4 | P1X_CLK | $\pm 0.1$ inches |
| R[A-E]_IN_P, R[A-E]_IN_N, RCK_IN_P, <br> RCK_IN_N | 2 | 3,4 | RCK | Differential signals need to be <br> matched within $\pm 12$ mils |

(1) Total signal length from the DLPC350 and the DMD, including flex cable traces and PCB signal trace lengths must be held to the lengths specified in Table 19.
(2) Switching routing layers is not permitted except at the beginning and end of a trace.
(3) Minimize vias on DMD traces.
(4) Matching includes PCB trace length plus the DLPC350 package length plus the DMD flex cable length.

### 11.1.7.4 Fiducials

Fiducials for automatic component insertion should be 0.05 inch diameter copper with a 0.1 -inch cutout (antipad). Fiducials for optical auto insertion are placed on three corners of both sides of the PCB.

### 11.1.7.5 Flex Considerations

Table 23 shows the general DMD flex design recommendations. Table 24 lists the minimum flex design requirements.

Table 23. Flex General Recommendations

| DESCRIPTION | RECOMMENDATION |
| :--- | :--- |
| Configuration | Two-layer micro strip |
| Reference plane 1 | Ground plan for proper return |
| Vias | Maximum two per signal |
| Single trace width | 4-mil minimum |
| Etch thickness $(T)$ | $0.5-\mathrm{oz} .(0.6$ mil thick) copper |
| Single-ended signal impedance | $50 \Omega( \pm 10 \%)$ |

Table 24. Minimum Flex Design Requirements

| PARAMETER | APPLICATION | SINGLE-ENDED SIGNALS | UNIT |
| :---: | :---: | :---: | :---: |
| Line width (W) ${ }^{(1)}$ | Escape routing in ball field | $\begin{gathered} 4 \\ (0.1) \end{gathered}$ | $\begin{gathered} \mathrm{mil} \\ (\mathrm{~mm}) \end{gathered}$ |
|  | PCB etch data and control | $\begin{gathered} 5 \\ (0.13) \end{gathered}$ | $\underset{(\mathrm{mm})}{\mathrm{mil}}$ |
|  | PCB etch clocks | $\begin{gathered} 7 \\ (0.18) \end{gathered}$ | $\begin{gathered} \mathrm{mil} \\ (\mathrm{~mm}) \end{gathered}$ |
| Minimum line spacing to other signals (S) | Escape routing in ball field | $\begin{gathered} 4 \\ (0.1) \end{gathered}$ | $\underset{(\mathrm{mm})}{\mathrm{mil}}$ |
|  | PCB etch data and control | 2 x the line width ${ }^{(2)}$ | $\begin{gathered} \text { mil } \\ (\mathrm{mm}) \end{gathered}$ |
|  | PCB etch clocks | $3 x$ the line width | $\begin{gathered} \text { mil } \\ (\mathrm{mm}) \end{gathered}$ |

(1) Line width is expected to be adjusted to achieve impedance requirements.
(2) Three times the line spacing is recommended for all signals to help achieve the desired signal integrity.

### 11.1.7.6 DLPC350 Thermal Considerations

The underlying thermal limitation for the DLPC350 controller is that the maximum operating junction temperature ( $\mathrm{T}_{\mathrm{J}}$ ) must not be exceeded (see Recommended Operating Conditions in Specifications). This temperature is dependent on operating ambient temperature, airflow, PCB design (including the component layout density and the amount of copper used), power dissipation of the DLPC350 controller, and power dissipation of surrounding components. The DLPC350 package is designed to extract heat through the power and ground planes of the PCB, thus copper content and airflow over the PCB are important factors.

### 11.2 Layout Example

### 11.2.1 Printed Circuit Board Layer Stackup Geometry

The DLPC350 PCB is targeted at six layers with layer stack up shown in Figure 25. The PCB layer stack may vary depending on system design. However, careful attention is required to meet design considerations. Layers one and six should consist of the components layers. Low-speed routing and power splits are allowed on these layers. Layer two should consist of a solid ground plane. Layer five should be a split voltage plane. Layers three and four should be used as the primary routing layers. Routing on external layers should be less than 0.25 inches for priority one and two signals. Refer to Table 22 for signal priority groups.
Board material should be FR-370HR or similar. PCB should be designed for lead-free assembly with the stackup geometry shown in Figure 25.

## Layout Example (continued)



Figure 25. Layer Stackup
Table 25. PCB Layer Stackup Geometry

| PARAMETER | DESCRIPTION | RECOMMENDATION |
| :--- | :--- | :--- |
| Reference plane 1 | Ground plane for proper return |  |
| Reference plane 2 | $1.9-\mathrm{V}$ DMD I/O power plane or ground |  |
| Er | Dielectric FR4 | 4.3 at $1 \mathrm{GHz}(\mathrm{nominal})$ |
| H 1 | Signal trace distance to reference plane 1 | $5 \mathrm{mil}(0.127 \mathrm{~mm})$ |
| H 2 | Signal trace distance to reference plane 2 | 30.4 mil |

### 11.2.2 Recommended DLPC350 MOSC Crystal Oscillator Configuration

The DLPC350 controller requires an external reference clock to feed its internal PLL. This reference may be supplied via a crystal or oscillator. The DLPC350 controller accepts a reference clock of 32 MHz with a maximum frequency variation of 100 ppm (including aging, temperature, and trim component variation). When a crystal is used, several discrete components are also required, as shown in Figure 26.
$C_{L}=$ Crystal load capacitance (Farads)
$\mathrm{C}_{\mathrm{L} 1}=2$ * $\left(\mathrm{C}_{\mathrm{L}}-\mathrm{C}_{\text {Stray-mosc }}\right)$
$\mathrm{C}_{\mathrm{L} 2}=2$ * $\left(\mathrm{C}_{\mathrm{L}}-\mathrm{C}_{\text {Stray-moscn }}\right)$
$\mathrm{C}_{\text {Stray-MOSC }}=$ Sum of Package \& PCB capacitance at the crystal pin associated with ASIC signal MOSC. $\mathrm{C}_{\text {stray-moscn }}=$ Sum of Package \& PCB capacitance at the crystal pin associated with ASIC signal MOSCN.


Figure 26. Recommended Crystal Oscillator Configuration
Table 26. Crystal Port Electrical Characteristics

|  | PARAMETER | NOM |
| :--- | ---: | ---: |
| UOSC to GND capacitance | UNIT |  |
| MOSCN to GND capacitance | 3.9 | pF |

Table 27. Recommended Crystal Configuration

| PARAMETER | RECOMMENDED | UNIT |
| :--- | :---: | :---: |
| Crystal circuit configuration | Parallel resonant |  |
| Crystal type | Fundamental (first harmonic) |  |
| Crystal nominal frequency | 32 | MHz |
| Crystal frequency tolerance (including accuracy, <br> temperature, aging and trim sensitivity) | $\pm 100$ | PPM |
| Crystal equivalent series resistance (ESR) | 50 max | $\Omega$ |
| Crystal load | 10 | pF |
| Crystal shunt load | 7 max | pF |
| Crystal frequency temperature stability | $\pm 30$ | PPM |
| $\mathrm{R}_{\mathrm{S}}$ drive resistor (nominal) | 100 | $\Omega$ |
| $\mathrm{R}_{\text {FB }}$ feedback resistor (nominal) | 1 | $\mathrm{M} \Omega$ |
| $\mathrm{C}_{\text {L1 }}$ external crystal load capacitor (MOSC) |  | pF |

Table 27. Recommended Crystal Configuration (continued)

| PARAMETER | RECOMMENDED | UNIT |
| :--- | :---: | :---: |
| $\mathrm{C}_{\mathrm{L} 2}$ external crystal load capacitor (MOSCN) | Typical drive level with TCX9C3207001 crystal <br> (ESRmax $=30 \Omega$ ) $=160 \mu \mathrm{~W}$. See Figure 26 | pF |
| PCB layout | A ground isolation ring around the crystal |  |

If an external oscillator is used, then the oscillator output must drive the MOSC pin on the DLPC350 controller, and the MOSCN pin should be left unconnected. The benefit of an oscillator is that it can be made to provide a spread-spectrum clock that reduces EMI. Note that the DLPC350 controller can only accept $0 \%, \pm 0.5 \%$, and $\pm 1.0 \%$ (center-spread modulation), and a triangular waveform.
Similar to the crystal option, the oscillator input frequency is limited to 32 MHz .
It is assumed that the external crystal or oscillator stabilizes within 50 ms after stable power is applied.

### 11.2.3 Recommended DLPC350 PLL Layout Configuration

High-frequency decoupling is required for both $1.2-\mathrm{V}$ and $1.8-\mathrm{V}$ PLL supplies and should be provided as close as possible to each of the PLL supply package pins as shown in the example layout in Figure 27. TI recommends that decoupling capacitors be placed under the package on the opposite side of the board. High quality, lowESR, monolithic, surface mount capacitors should be used. Typically $0.1 \mu \mathrm{~F}$ for each PLL supply should be sufficient. The length of a connecting trace increases the parasitic inductance of the mounting and thus, where possible, there should be no trace, allowing the via to butt up against the land itself. Additionally, the connecting trace should be made as wide as possible. Further improvement can be made by placing vias to the side of the capacitor lands or doubling the number of vias.
The location of bulk decoupling depends on the system design. Typically, a good ceramic capacitor in the $10-\mu \mathrm{F}$ range is adequate.


Figure 27. PLL Filter Layout

## 12 Device and Documentation Support

### 12.1 Device Support

### 12.1.1 Video Timing Parameter Definitions

The following is a list of the typical input video timing parameters and their definitions.
Active Lines Per Frame (ALPF) Number of lines in a frame containing displayable data. This is a subset of the TLPF
Active Pixels Per Line (APPL) Number of pixel clocks in a line containing displayable data. This is a subset of the TPPL
Horizontal Back Porch (HBP) Blanking Number of blank pixel clocks after Horizontal Sync but before the first active pixel. HBP times are in reference to the leading (active) edge of the respective sync signal
Horizontal Front Porch (HFP) Blanking Number of blank pixel clocks after the last active pixel but before horizontal sync
Horizontal Sync (HS) Timing reference point that indicates the start of the horizontal interval (line). The absolute reference point is defined by the active edge of the HS signal. This active edge is the reference from which all horizontal blanking parameters are measured
Total Lines (Active and Inactive) Per Frame (TLPF) Defines the vertical period (or frame time) in lines
Total Pixel Per Line (TPPL) Horizontal line period in pixel clocks. Total number of active and inactive pixel clocks per line
Vertical Back Porch (VBP) Blanking Number of blank lines after Vertical Sync but before the first active line
Vertical Front Porch (VFP) Blanking Number of blank lines after the last active line but before vertical sync
Vertical Sync (VS) Timing reference point that indicates the start of the vertical interval (frame). The absolute reference point is defined by the active edge of the VS signal. This active edge is the reference from which all vertical blanking parameters are measured

### 12.1.2 Device Nomenclature

Figure 28 provides a legend for reading the complete device name for any DLP $^{\circledR}$ catalog device.


Figure 28. Device Nomenclature

## Device Support (continued)

### 12.1.3 Device Marking

The device marking consists of the fields shown in Figure 29.


Figure 29. Device Marking

### 12.2 Documentation Support

### 12.2.1 Related Documentation

- DLP4500 0.45 WXGA DMD Datasheet (DLPS028)
- DLP4500NIR 0.45 WXGA DMD Datasheet (DLPS032)
- DLPC350 Programmer's Guide (DLPU010)
- DLPC350 Configuration and Support Firmware (DLPR350)


### 12.3 Trademarks

DLP is a registered trademark of Texas Instruments.
All other trademarks are the property of their respective owners.

### 12.4 Electrostatic Discharge Caution

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### 12.5 Glossary

SLYZ022 - TI Glossary.
This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable Device | Status <br> (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan <br> (2) | Lead/Ball Finish <br> (6) | MSL Peak Temp <br> (3) | Op Temp ( ${ }^{\circ} \mathrm{C}$ ) | Device Marking <br> (4/5) | Samples |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DLPC350ZFF | ACTIVE | BGA | ZFF | 419 | 5 | TBD | Call TI | Call TI |  |  | Samples |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but Tl does not recommend using this part in a new design
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.
${ }^{(2)}$ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS \& no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details
TBD: The Pb-Free/Green conversion plan has not been defined
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
Green (RoHS \& no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1\% by weight in homogeneous material)
${ }^{(3)}$ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
${ }^{(4)}$ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
${ }^{(5)}$ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
${ }^{(6)}$ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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| $\phi \mid$ |
| :--- |

NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
B. This drawing is subject to change without notice.
C. This package is Pb -free.

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## Products

Audio
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DLP® Products
DSP
Clocks and Timers
Interface
Logic
Power Mgmt
Microcontrollers
RFID
OMAP Applications Processors
Wireless Connectivity

## Applications

Automotive and Transportation
Communications and Telecom
Computers and Peripherals
Consumer Electronics
Energy and Lighting
Industrial
Medical
Security
Space, Avionics and Defense
Video and Imaging

## TI E2E Community

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www.ti.com/video
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[^0]:    (1) Meets $I^{2} C$ timing per the $I^{2} C$ Bus Specification, unless otherwise noted. For reference see version 2.1 of the Phillips/NXP specification.
    (2) The maximum clock frequency does not account for rise time, nor added capacitance of PCB or external components which may adversely impact this value.
    (3) By definition, $\mathrm{I}^{2} \mathrm{C}$ transactions will operate at the speed of the slowest device on the bus and thus there is no requirement to match the speed grade of all devices in the system. However if Full-speed operation is desired, it will be necessary to ensure the other $I^{2} \mathrm{C}$ devices support full-speed operation as well. In addition to other devices slowing down bus operation, the length of the line (due to its capacitance) and the value of the $I^{2} \mathrm{C}$ pullup resistors will also influence the max achievable speed.
    (4) The data setup time should be greater than 300 ns . This differs from the I2C specification.

